# C urrent recti cation, sw itch ing, polarons, and defects in $m$ olecular electron ic devices 

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D evices for nano- and molecular size electronics are currently a focus of research aim ed at an e cient current recti cation and sw itching. 1 A few generic m olecular scale devioes are review ed here on the basis of rst-principles and m odelapproaches. C urrent recti cation by (ballistic) m olecular quantum dots can produce the recti cation ratio 100. Current sw itching due to conform ational changes in the m olecules is slow, on the order of a few kHz . Fast sw itching ( 1 THz ) may be achieved, at least in principle, in a degenerate $m$ olecular quantum dot $w$ ith strong coupling of electrons $w$ ith vibrationalexcitations. $W$ e show that the $m$ ean- eld approach fails to properly describe intrinsic $m$ olecular sw itching and present an exact solution to the problem. $D$ efects in $m$ olecular $\mathrm{m} s$ result in spurious peaks in conductance, apparent negative di erential resistance, and $m$ ay also lead to unusualtem perature and bias dependence of current. T he observed sw itching in $m$ any cases is extrinsic, caused by changes in $m$ olecule-electrode geom etry, $m$ olecule recon guration, $m$ etallic lam ent form ation through, and/or changing am ount ofdisorder in a molecular m . W e give experim ental exam ples of telegraph "sw itching" and "hot spot" form ation in the molecular m s .

## 1 Introduction

Current interest in $m$ olecular electronics is largely driven by expectations that m olecules can be used as nanoelectronics com ponents able to com ple$m$ ent/replace standard silicon CM OS technology [1, [2] on the way down to 10 nm circuit com ponents. The rst speculations about m olecular electronic devices (diodes, recti ens) were apparently $m$ ade in $m$ id-1970s [3]. That originalsuggestion of a m olecular recti er has generated a large interest in the eld

[^0]and a urry of suggestions of various $m$ olecular electronics com ponents, especially coupled w ith prem ature estim ates that silicon-based technology cannot scale to below 1 m feature size. The A viram $R$ atner's D onor-insulatorA cceptor construct T TF TCNQ (D ${ }^{+}$A ; see details below ), where carriers w ere supposed to tunnel asym $m$ etrically in tw o directions through insulating saturated $m$ olecular bridge', has neverm aterialized, in spite ofextensive experim entale ort over a few decades [4]. E nd result in som e cases appears to be a slightly electrically anisotropic insulator, rather than a diode, unsuitable as a replacem ent for silicon devioes. T his com es about because in order to assem ble a reasonable quality $m$ onolayer of these $m$ olecules in Langm uirB lodgett trough (avoiding defects that will short the devioe after electrode deposition) one needs to attach a long tail' m olecule C 18 [ ( $\left.\mathrm{CH}_{2}\right)_{18}$ ] that can produce enough of a Van-der-W aals force to keep molecules together, but C 18 is a w ide-band insulator w th a bandgap $\mathrm{E}_{\mathrm{g}} \quad 9 \quad 10 \mathrm{eV}$. The outcom e of these studies $m$ ay have been anticipated, but if one were able to assem ble the A viram $R$ atner $m$ olecules w ithout the tail, they could not rectify anyw ay. Indeed, a recent ab-initio study [5] of $D^{+}$A prospective molecule showed no appreciable asym $m$ etry of its $I-V$ curve. The m olecule was envisaged by E llenbogen and Love [6] as a 4-phenylring Tourw ire w ith dim ethylene insulating bridge in the $m$ iddle directly connected to $\mathrm{A} u$ electrodes via thiol groups. D onor-acceptor asym $m$ etry was produced by side $\mathrm{NH}_{2}^{+}$and $\mathrm{NO}_{2}$ m oieties, $w$ hich is a frequent $m$ otif in $m$ olecular devices using the Tour $w$ ires. The reason of poor recti cation is sim ple: the bridge is too short, it is a transparent piece of one-dim ensional insulator, whereas the applied eld is three dim ensional and it cannot be screened e ciently w ith an appreciable voltage drop on the insulating group in this geom etry. A though there is only 0.7 eV energy separation betw een levels on the D and A groups, one needs about 4eV bias to align them and get a relatively sm all current because total resonant transparency is practically im possible to achieve. Rem em ber, that the m odel calculation im plied an ideal coupling to electrodes, which is im possible in reality and which is known to dram atically change the current through the m olecule (see below ). W e shalldiscuss below som e possible altematives to this approach.

It is worth noting that studies of energy and electron transport in $m$ olecular crystals [7] started already in early 1960s. It w as established in m id-1960s in what circum stances charge transport in biologicalm olecules involves electron tunneling [8]. It w as realized in $m$ id-1970s that since the organ ic m olecules are soft', energy transport along linear biological m olecules, proteins, etc. $m$ ay proceed by low energy nonlinear collective excitations, like D avydov solitons [9] (see review [10]).

To take over from current silicon CM OS technology, the m olecular electronics should provide sm aller, $m$ ore reliable, functional com ponents that can be produced and assembled concurrently and are com patible w th CM OS for integration. T he sm all size of units that $m$ olecules $m$ ay hopefiully provide is quite obvious. H ow ever, $m$ eeting other requirem ents seem $s$ to be a
very long shot. To beat altemative technologies for e.g. dense (and cheap) m em ories, one should aim at a few $\mathrm{Tb} / \mathrm{in}^{2} \quad\left(>10^{12} \quad 10^{3} \mathrm{~b}\right.$ it $\left./ \mathrm{cm}^{2}\right)$, which corresponds to linear bit (footprint) sizes of 310 nanom eters, and an operation lifetim e of 10 years. The latter requirem ent is very di cult to m eet $w$ ith organic $m$ olecules that tend to oxidize and decom pose, especially under conditions of very high applied electric eld (given the operational voltage bias of $1 V$ for m olecules integrated with CMOS and their sm all sizes on the order of a few nanom eters). In term s of areal density, one should com pare this w ith rapidly developing technologies like ferroelectric random access (FERAM) [11] or phase-change mem ories (PCM) [12]. The current sm allest com $m$ ercial nano-ferroelectrics are about $400400 \mathrm{~nm}^{2}$ and 20-150 nm thick [13], and the 128128 arrays of Sw itching ferroelectric pixels bits have been already dem onstrated $w$ th abit size 50 nm ( w th density $\mathrm{Tb} / \mathrm{i}$ ) [14]. The phase-change $m$ em ories based on chalcolgenides $G$ eSbTe (G ST ) seem to scale even better than the ferroelectrics. A s we see, the $m$ ainstream technology for random -access $m$ em ory approaches $m$ olecular size very rapidly. At the sam e tim e, the so-called \nanopore" m olecular devioes [35] have com parable sizes and yet to dem onstrate a repeatable behavior (for reasons explained below ).

In term s of parallel fabrication ofm olecular devioes, one is looking at selfassem bly techniques (see, e.g. [15, [16], and references therein). Frequently, the Langm uir-B lodgett technique is used for self-assem bly ofm olecules on water, where molecules are prepared to have hydrophilic \head" and hydrophobic \tail" to $m$ ake the assem bly possible, see e.g. Refs. [17, 18]. T he allow ances for a corresponding assem bly, especially of hybrid structures (m olecules integrated on silicon CMOS), are on the order of a fraction of an A ngstrom, so actually a picotechnology is required [2]. Since it is problem atic to reach such a precision any tim e soon, the all-in-one molecule approach was advocated, $m$ eaning that a fully functional com puting unit should be synthesized as a single superm olecular unit [2]. The hope is that perhaps directed self-assem bly w illhelp to accom plish building such a unit, but self-assem bly on a large scale is im possible w thout defects [15, [16], since the entropic factors work against it. A bove som e sm alldefect concentration (percolation") threshold the m apping of even a simple algorithm on such a self-assem bled netw ork becom es im possible [19].

There is also a big question about electron transport in such a device consisting of large organic molecules. Even in high-quality pentacene (P 5) crystals, perhaps the best $m$ aterials for thin $l m$ transistors, the $m$ obility is a $m$ ere $1-2 \mathrm{~cm}^{2} / \mathrm{V} \quad \mathrm{s}$ (see e. . 20 JJ ), as a result of carrier trapping by interaction w ith a lattice and necessity to hop betw een P 5 m olecules. The situation w ith carrier transport through long m olecules ( $>23 \mathrm{~nm}$ ) is, of course, substantially different from the transport through short rigid $m$ olecules that have been envisaged as possible electronics com ponents. Indeed, in short $m$ olecules the dom inant m ode of electron transport w ould be resonant tunneling through electrically active m olecular orbital(s) [21], which, depending on the workfunction of the electrode, a nity of the $m$ olecule, and sym $m$ etry of coupling betw een
$m$ olecule and electrode $m$ ay be one of the low est unoccupied m olecular orbitals (LUM O ) or highest occupied m olecular orbitals (H O M O) 22, 23]. Indeed, it is well know $n$ that in longer $w$ ires containing $m$ ore than about 30-40 atom ic sites, the tunneling tim e is com parable to or larger than the characteristic phonon tim es, so that the polaron (and/or bipolaron) can be form ed inside the m olecular wire [24]. There is a wide range of $m$ olecular bulk conductors w ith (bi)polaronic carriers. $T$ he form ation of polarons (and charged solitons) in polyacetylene (PA ) was discussed a long tim e ago theoretically in Refs. [25] and form ation of bipolarons (bound states of two polarons) in Ref.[26]. Polarons in PA w ere detected optically in R ef. (27] and since then studied in great detail. There is an exceeding am ount of evidence of the polaron and bipolaron form ation in con jugated polym ers such as polyphenylene, polypyrrole, polythiophene, polyphenylene sul de [28], C s-doped biphenyl [29], n-doped bithiophene [30], polyphenylenevinylene (P P V ) -based light em itting diodes [31], and other molecular system s . B oth intrinsic and extrinsic param eters play a role in determ ining the electrical and optical properties of polym er m s: spatial range of -electron delocalization, interchain interaction, $m$ onphology, am ount of defects and disorder, carrier density, etc (for a brief review of carrier transport $m$ echanism $s$ and $m$ aterials see $R$ ef. [32]).

The latest $w$ ave of interest in $m$ olecular electronics is $m$ ostly related to recent studies of carrier transport in synthesized linear conjugated molecular w ires (Tour wires(1]) w ith apparent non-linear I-V characteristics [negative di erential resistance (NDR)] and \m em ory" e ects [33, 34, 35], various $m$ olecules $w$ th a m obile $m$ icrocycle that is able to $m$ ove back and forth betw een $m$ etastable conform ations in solution ( $m$ olecular shuttles) [36] and dem onstrate som e sort of \sw itching" betw een relatively stable resistive states when sandw iched betw een electrodes in a solid state device (37] (see also [38]). $T$ here are also various photochrom ic $m$ olecules that $m$ ay change conform ation (\sw itch") upon absonption of light [39], which may be of interest to som e photonics applications but not for the general purpose electronics. O ne of the $m$ ost serious problem $s w$ th using this kind ofm olecules is power dissipation. Indeed, the studied organic m olecules are, as a rule, very resistive (in the range of $1 M \quad 1 G$, orm ore). Since usually the $s w$ itching bias exceeds $0: 5 \mathrm{~V}$ the dissipated pow er density would be in excess of $10 \mathrm{~kW} / \mathrm{cm}^{2}$; which is orders ofm agnitude higher than the presently $m$ anageable level. O ne can drop the density of sw itching devioes, but this w ould underm ine a m ain advantage of using $m$ olecular size elem ents. $T$ his is a com $m$ on problem that CM OS faces too, but organicm olecules do not seem to o er a tangible advantage yet. T here are other outstanding problem s , like understanding an actualsw itching $m$ echanism, which seem $s$ to be rather $m$ olecule-independent [38], stability, scaling, etc. It is not likely, therefore, that m olecules will displace silicon technology, or becom e a large part of a hybrid technology in a foreseeable future.
$F$ irst $m$ a jor $m$ oletronic applications would $m$ ost likely com $e$ in the area of chem ical and biological sensors. O ne of the current solutions in this area is to use the functionalized nanow ires. $W$ hen a target analyte $m$ olecule attaches
from the environm ent to such a nanow ire, it changes the electrostatic potential \seen" by the carriers in the nanow ire. Since the conductance of the nanow ire device is sm all, even one chem isorbed $m$ olecule could $m$ ake a detectable change of a conductance [40]. Sem iconducting nanow ires can be grow $n$ from seed $m$ etal nanoparticles [15], or it can be carbon nanotubes (CNT), which are studied extensively due to their relatively sim ple structure and som e unique properties like very high conductance [41].

In this paper we shall address various generic problem s related to electron transport through m olecular devices, and describe som e speci c m olecular system $s$ that $m$ ay be interesting for applications as recti ers and sw itches, and som e pertaining physicalproblem s.W e shall rst consider system swhere an elastic tunneling is dom inant, and interaction $w$ ith vibrationalexcitations on the molecules only renom alizes som e param eters describing tunneling. W e shall also describe a situation where the coupling of carriers to m olecular vibrons is strong. In this case the tunneling is substantially inelastic and, m oreover, it m ay result in current hysteresis $w$ hen the electron-vibron interaction is so strong that it overcom es C oulom b repulsion of carriers on a central narrow -band/con jugated unit of the m olecule separated from electrodes by w ide band gap saturated m olecular groups like ( $\left.\mathrm{CH}_{2}\right)_{\mathrm{n}}$; which we shall call a molecular quantum dot ( $m \circ l \mathrm{D}$ ). A nother very im portant problem is to understand the nature and the role of im perfections in organic thin m s . It is addressed in the last section of the paper.

## 2 R ole of $m$ olecule-electrode contact: extrinsic molecular sw itching due to $m$ olecule tilting

W e have predicted som e while ago that there should be a strong dependence of the current through conjugated molecules (like the Tour wires [1]) on the geom etry of $m$ olecule-electrode contact [22, 23]. The apparent \telegraph" sw itching observed in STM single-m olecule probes of the three-ring Tour m olecules, inserted into a SAM of non-conducting shorter alkanes, has been attributed to this e ect [34]. The theory predicts very strong dependence of the current through the $m$ olecule on the tilting angle betw een a backbone of a m olecule and a norm al to the electrode surface. O ther explanations, like rotation of the $m$ iddle ring, charging of the $m$ olecule, or e ects of the $m$ oieties on the $m$ iddle ring, do not hold. In particular, sw itching of the $m$ olecules $w$ ithout any $\mathrm{NO}_{2}$ or $\mathrm{NH}_{2} \mathrm{~m}$ oieties have been practically the sam e as with them.

The sim ple argum ent in favor of the \tilting" $m$ echanism of the conductance lies in a large anisotropy of the molecule-electrode coupling through -con jugated m olecular orbitals (M O s). In general, we expect the overlap and the fill conductance to be $m$ axim alw hen the lobes of the p-orbital of the end atom at the $m$ olecule are oriented penpendicular to the surface, and sm aller otherw ise, as dictated by the sym $m$ etry. $T$ he overlap integrals of a p-onbital


Fig. 1. Schem atic representation of the benzene-dithiolate molecule on top and hollow sites. End sulfur atom $s$ are bonded to one and three surface gold atom $s$, respectively, is the tilting angle.
$w$ ith orbitals of other types di er by a factor about 3 to 4 for the two orientations. Since the conductance is proportional to the square of the $m$ atrix elem ent, which contains a product of tw o m etal-m olecule hopping integrals, the total conductance variation $w$ ith overall geom etry m ay therefore reach tw o orders ofm agnitude, and in special cases be even larger.

In order to illustrate the geom etric e ect on current we have considered a simple two-site m odelw ith p orbitals on both sites, coupled to electrodes w ith s orbitals 23]. For non-zero bias the transm ission probability has the resonant form (5) $w$ ith line $w$ idths for hopping to the left (right) lead $L$ $\left(\mathrm{R}_{\mathrm{R}}\right)$ : The current has the approxim ate form ( w ith $=\mathrm{L}+\mathrm{R}$ )

$$
\begin{gather*}
\frac{q^{2}}{h} \frac{2}{t^{2}} V / \sin ^{4} ; q V \quad E_{L U M O} \\
\frac{8 q}{h} \frac{E_{H O M O}}{} / \sin ^{2} ; q V>E_{L U M O}  \tag{1}\\
E_{H O M O} ;
\end{gather*}
$$

where is the tilting angle [23, 22], Fig. 1.
The tilting angle has a large e ect on the $I-V$ curves ofbenzene-dithiolate (BDT) m olecules, especially when the molecule is anchored to the Au electrode in the top position, Fig . 2 . By changing from 5 to just 15 , one drives the I-V characteristic from the one w ith a gap of about 2 V to the ohm ic one w ith a large relative change of conductance. Even changing from 10 to 15 changes the conductance by about an order ofm agnitude. The I-V curve for the hollow site rem ains ohm ic for tilting angles up to 75 w ith m oderate changes of conductance. Therefore, if the $m$ olecule in $m$ easurem ents snaps from the top to the hollow position and back, it will lead to an apparent

Sw itching [34]. It has recently been realized that the geom etry of a contact strongly a ects coherent spin transfer betw een molecularly bridged quantum dots [42]. It is w orth noting that another frequently observed extrinsic m echanism of \sw itching" in organic layers is due to electrode $m$ aterial di using into the layer and form ing $m$ etallic $\backslash$ lam ents" (see below).


Fig.2. E ect of tilting on IV curve of the BD T m olecule, Fig. 1 . C urrent is in units of $I_{0}=77: 5 \mathrm{~A}$, is the tilting angle.

## 3 M olecular quantum dot recti ers

A viram and $R$ atner speculated about a rectifying $m$ olecule containing donor (D) and acceptor (A) groups separated by a saturated bridge (insulator) group, where the (inelastic) electron transfer w illbe m ore favorable from $A$ to D [3]. Them olecular recti ers actually synthesized, $\mathrm{C}_{16} \mathrm{H}_{33} \quad \mathrm{Q} 3 \mathrm{CNQ}$, were of som ew hat di erent D A type, i.e. the \bridge" group was con jugated [4]. A though the $m$ olecule did show recti cation (w ith considerable hysteresis), it perform ed rather like an anisotropic insulator with tiny currents on the order of $10{ }^{17} \mathrm{~A} / \mathrm{m}$ olecule, because of the large alkane \tail" needed for LB assem bly. It was recently realized that in this molecule the resonance does not com e from the alignm ent of the HOMO and LUM O, since they cannot be decoupled through the conjugated bridge, but rather due to an asym $m$ etric
voltage drop across the m olecule [43]. Rectifying behavior in other classes of m olecules is likely due to asym m etric contact w ith the electrodes [44, 45], or an asym $m$ etry of the $m$ olecule itself [46]. To $m$ ake recti ers, one should avoid using $m$ olecules $w$ ith long insulating groups, and we have suggested using relatively short $m$ olecules $w$ th "anchor" end groups for their self-assem bly on a m etallic electrodes, w th a phenyl ring as a central con jugated part [47]. This idea has been tested in Ref. [48] w ith a phenyl and thiophene rings attached to a $\left(\mathrm{CH}_{2}\right)_{15}$ tail by a CO group. The observed recti cation ratio was 10, w th som e sam ples show ing the ratio of about 37.

W e have recently studied a m ore prom ising recti er like $\mathrm{S}-\left(\mathrm{C} \mathrm{H}_{2}\right)_{2}-\mathrm{N}$ aph $\left(\mathrm{CH}_{2}\right)_{10} \quad \mathrm{~S} \quad \mathrm{w}$ th a theoreticalrecti cation 10[49], F ig. 3. Th is system has been synthesized and studied experim entally 50]. To obtain an accurate description of transport in this case, we em ploy an ab-initio non-equilibrium G reen's function m ethod [51]. T he present calculation takes into account only elastic tunneling processes. Inelastic processes $m$ ay substantially $m$ odify the results in the case of strong interaction of the electrons $w$ ith m olecular vibrations, see Ref. [52] and below. There are indications in the literature that the carrier m ight be trapped in a polaron state in saturated $m$ olecules som ew hat longer than those we consider in the present paper [53]. O ne of the barriers in the present recti ers is short and relatively transparent, so there willbe no appreciable C oulom b blockade e ects. T he structure of the present m olecular recti er is shown in $F$ ig. 3. The m olecule consists of a centralcon jugated part (naphthalene) isolated from the electrodes by two insulating aliphatic chains ( $\left.\mathrm{CH}_{2}\right)_{\mathrm{n}} \mathrm{w}$ ith lengths $\mathrm{L}_{1}\left(\mathrm{~L}_{2}\right)$ for the left (right) chain.


Fig. 3. Stick gure representing the naphthalene con jugated centralunit separated from the left (right) electrode by saturated (w ide band gap) alkane groups w ith length $\mathrm{L}_{1 \text { (2) }}$ 。

The principle of $m$ olecular recti cation by a m olecular quantum dot is illustrated in F ig. 4, w here the electrically \active" m olecular orbital, localized on them iddle conjugated part, is the LUM O, which lies at an energy above
the electrode Fem ilevelat zero bias. T he position of the LUM O is determ ined by the work function of the $m$ etal $q$ and the a nity of the $m$ olecule $q$;
$=$ LUMO $=\mathrm{q}(\quad):$ The position of the HOMO is given by $\mathrm{HOMO}=$
LUM O $\mathrm{E}_{\mathrm{g}}$; where $\mathrm{E}_{\mathrm{g}}$ is the HOMO LUMO gap. Ifthis orbital is considerably closer to the electrode Fem ilevelE $\mathrm{E}_{\mathrm{F}}$; then it w ill be brought into resonance w th $\mathrm{E}_{\mathrm{F}}$ prior to other orbitals. It is easy to estim ate the forw ard and reverse bias voltages, assum ing that the voltage $m$ ainly drops on the insulating parts of the m olecule,

$$
\begin{gather*}
\mathrm{V}_{\mathrm{F}}=\bar{q}(1+) ; \quad \mathrm{V}_{\mathrm{R}}=\bar{q} 1+\frac{1}{q} ;  \tag{2}\\
\mathrm{V}_{\mathrm{F}}=\mathrm{V}_{\mathrm{R}}=\quad \mathrm{L}_{1}=\mathrm{L}_{2} ; \tag{3}
\end{gather*}
$$

where $q$ is the elem entary charge. A signi cant di erence betw een forw ard and reverse currents should be observed in the voltage range $V_{F}<j v j<V_{R}$. $T$ he current is obtained from the Landauer form ula

$$
\begin{equation*}
I=\frac{2 q^{2}}{h} d E\left[f(E) \quad f\left(E+q^{Z}\right)\right] g(E ; V): \tag{4}
\end{equation*}
$$

W e can m ake qualitative estim ates in the resonant tunneling $m$ odel, $w$ th the conductance $\mathrm{g}(\mathrm{E} ; \mathrm{V}) \quad \mathrm{T}(\mathrm{E} ; \mathrm{V})=\mathrm{q}$; where $\mathrm{T}(\mathrm{E} ; \mathrm{V})$ is the transm ission given by the Breit-W igner form ula

$$
\begin{equation*}
T(\mathbb{E} ; V)=\frac{L R}{\left(E \quad E_{M} \circ\right)^{2}+(L+R)^{2}=4} ; \tag{5}
\end{equation*}
$$

$E_{M} \circ$ is the energy of the m olecular onbital. $T$ he width $L(R) \quad Z^{2}=D=$ ${ }_{0} e^{2}{ }^{L_{1(2)}}$; where $t$ is the overlap integralbetw een the M $O$ and the electrode, $D$ is the electron band width in the electrodes, the inverse decay length of the resonant M O into the barrier. T he current above the resonant threshold is

$$
\begin{equation*}
\text { I } \frac{2 q}{h} o^{2 L_{2}}: \tag{6}
\end{equation*}
$$

$W$ e see that increasing the spatialasym $m$ etry ofthe $m$ olecule ( $L_{2}=L_{1}$ ) changes the operating voltage range linearly, but it also brings about an exponential decrease in current [47]. T his severely lim its the ability to optim ize the recti cation ratio while sim ultaneously keeping the resistance at a reasonable value. To calculate the I-V curves, we use an ab-initio approach that com bines the K eldysh non-equilibrium G reen's function (NEGF) w ith pseudopotentialbased real space density functional theory (DFT) 51]. The m ain advantages of our approach are (i) a proper treatm ent of the open boundary condition; (ii) a fully atom istic treatm ent of the electrodes and (iii) a self-consistent calculation of the non-equilibrium charge density using NEGF. T he transport G reen's function is found from the Dyson equation

$$
\begin{equation*}
\mathrm{G}^{\mathrm{R}} \quad{ }^{1}=\mathrm{G}_{0}^{\mathrm{R}}{ }^{1} \quad \mathrm{~V} ; \tag{7}
\end{equation*}
$$



Fig. 4. Transm ission coe cient versus energy $E$ for recti ens $S-\left(\begin{array}{ll}\mathrm{CH}_{2}\end{array}\right)_{2}-$ $\mathrm{C}_{10} \mathrm{H}_{6}\left(\mathrm{CH}_{2}\right)_{\mathrm{n}} \mathrm{S} ; \mathrm{n}=2 ; 4 ; 6 ; 10$. indicates the distance of the closest M O to the electrode Ferm ienergy ( $\mathrm{E}_{\mathrm{F}}=0$ ).
where the unpertunbed retarded $G$ reen's function is de ned in operator form as $G_{0}^{R}{ }^{1}=(E+i 0) \hat{S} \hat{H} ; H$ is the $H$ am iltonian $m$ atrix for the scatterer ( $m$ olecule phis screening part of the electrodes). $S$ is the overlap $m$ atrix, $S_{i ; j}=$ $h_{i j}{ }_{j i}$ for non-orthogonalbasis set orbitals $i$, and the coupling of the scatterer to the leads is given by the H am iltonian m atrix $\mathrm{V}=\operatorname{diag}[\quad$;i; $0 ; ~ r ; r] ;$ where l(r) stands for left (right) electrode. T he selfenergy part < ; which is used to construct the non-equilibrium electron density in the scattering re-
 is the self-energy of the left (right) electrode, calculated for the sem i-in nite leads using an iterative technique [51]. < accounts for the steady charge \ ow ing in" from the electrodes. The transm ission probability is given by

$$
\begin{equation*}
\mathrm{T}(\mathbb{E} ; \mathrm{V})=4 \operatorname{Tr}(\operatorname{Im} \quad 1 ; 1) \mathrm{G}_{1 ; \mathrm{r}}^{\mathrm{R}}(\mathrm{Im} \quad \mathrm{r} ; \mathrm{r}) \mathrm{G}_{\mathrm{r} ; 1}^{\mathrm{A}} ; \tag{8}
\end{equation*}
$$

where $G^{R(A)}$ are the retarded (advanced) $G$ reen's function, and the selfenergy part connecting left (l) and right (r) electrodes [51], and the current is obtained from Eq. (4). The calculated transm ission coe cient $T$ ( E ) is show $n$ for a series of recti ers $\quad \mathrm{S}-\left(\mathrm{C} \mathrm{H}_{2}\right)_{\mathrm{m}}-\mathrm{C}_{10} \mathrm{H}_{6} \quad\left(\mathrm{CH}_{2}\right)_{\mathrm{n}} \quad \mathrm{S}$ form $=2$ and $n=2 ; 4 ; 6 ; 10$ at zero bias voltage in $F$ ig. 4. $W$ e see that the LUM $O$ is the $m$ olecular orbital transparent to electron transport, lies above $\mathrm{E}_{\mathrm{F}}$ by an am ount $=1: 2 \quad 1: 5 \mathrm{eV}$. The transm ission through the HOMO and HOMO-1 states, localized on the term inating sulfur atom s , is negligible, but the HOM O 2 state conducts very well. The HOMO-2 de nes the threshold reverse voltage $V_{R}$; thus lim iting the operating voltage range. O ur assum ption, that the voltage drop is proportional to the lengths of the alkane groups on both sides, is
quanti ed by the calculated potential ram $p$. It is close to a linear slope along the ( $\left.\mathrm{CH}_{2}\right)_{\mathrm{n}}$ chains [49]. The forw ard voltage corresponds to the crossing of the LUMO $(V)$ and $R(V)$, which happens at about $2 V$. A though the LUM $O$ denes the forw ard threshold voltages in allm olecules studied here, the reverse voltage is de ned by the HOMO-2 for \right" barriers ( $\left.\mathrm{CH}_{2}\right)_{\mathrm{n}}$ w ith $\mathrm{n}=6 ; 10$. $T$ he IV curves are plotted in $F$ ig. 5. W e see that the recti cation ratio for


Fig. 5. I-V curves for naphthalene recti ers $\quad \mathrm{S}-\left(\mathrm{CH}_{2}\right)_{2}-\mathrm{C}_{10} \mathrm{H}_{6} \quad\left(\mathrm{CH}_{2}\right)_{\mathrm{n}} \quad \mathrm{S} \quad ; \mathrm{n}=$ $2 ; 4 ; 6 ; 10$. The short-dash-dot curve corresponds to a cyano-doped (added group -C N) n = 10 recti er.
current in the operation window $I_{+}=I$ reaches a $m$ axim um value of 35 for the $\backslash 2-10 " m$ olecule ( $m=2 ; n=10$ ): Series ofm olecules $w$ ith a central single phenyl ring [47] do not show any signi cant recti cation. O ne can manipulate the system in order to increase the energy asym $m$ etry of the conducting orbitals (reduce ). To shift the LUM O towards $E_{F}$, one can attach an electron w ithdraw ing group, like C N 49]. Them olecular recti cation ratio is not great by any $m$ eans, but one should bear in $m$ ind that this is a device necessarily operating in a ballistic quantum $-m$ echanical regim e because of the sm all size. This is very di erent from present Sideviees w ith carriers di using through the system. As silicon devices becom e sm aller, how ever, the sam e
e ects w ill eventually take over, and tend to dim inish the recti cation ratio, in addition to e ects of nite tem perature and disorder in the system.

## 4 M olecular sw itches

T here are variousm olecular system sthat exh ibit som e kind ofcurrent \sw itching" behavior [34, 36, 37, 38], \negative di erential resistance" [33], and $\backslash \mathrm{m}$ em ory" [35]. The sw itching system s are basically driven betw een tw o states w ith considerably di erent resistances. This behavior is not really sensitive to a particular m olecular structure, since this type of bistability is observed in com plex rotaxane-likem olecules asw ellas in very sim ple alkane chains ( $\left.\mathrm{CH}_{2}\right)_{\mathrm{n}}$ assembled into LB m s [38], and is not even exclusive to the organic ms . $T$ he data strongly indicates that the sw itching has an extrinsic origin, and is related either to bistability of $m$ olecule-electrode orientation [22, 23, 34], or transport assisted by defects in the lm 54, 55].
4.1 Extrinsic sw itch ing in organ ic molecular lm s: role of defects and $m$ olecular recon gurations

Evidently, large defects can be form ed in organic thin lm s as a result of electrom igration in very strong eld, as was observed long ago [56]. It was concluded som e decades ago that the conduction through absorbed [54] and Langm uir-B lodgett [55] m onolayers of fatty acids ( $\left.\mathrm{CH}_{2}\right)_{\mathrm{n}}$; which we denote as Cn , is associated w ith defects. In particular, P olym eropoulos and Sagiv studied a variety of absorbed $m$ onolayers from $C 7$ to $C 23$ on $A 1 / A l_{2} O_{3}$ substrates and found that the exponential dependence on the length of the m olecular chains is only observed below the liquid nitrogen tem perature of 77 K , and no discemible length dependence was observed at higher tem peratures [54]. $T$ he tem perature dependence of current was strong, and was attributed to transport assisted by som e defects. T he current also varied strongly w th the tem perature in Ref. 55] for $\mathrm{LB} \quad \mathrm{ms}$ on $\mathrm{Al} / \mathrm{Al}_{2} \mathrm{O}_{3}$ substrates in He atm osphere, which is not com patible w ith elastic tunneling. Since the He atm osphere w as believed to hinder the $\mathrm{Al}_{2} \mathrm{O}_{3}$ grow th, and yet the resistance of the m s increased about 100-fold over 45 days, the conclusion wasm ade that the \defects" som ehow anneal out with time. Two types of sw itching have been observed in 3-30 m thick m s of polydim ethylsiloxane (PDMS), one as a standard dielectric breakdow $n$ w ith electrode $m$ aterial \jet evaporation" into the lm w ith subsequent Joule $m$ elting ofm etallic lam ent underbias ofabout 100V, and a low-voltage (< 1 V ) \ultrasw itching" that has a clear \telegraph" character and resulted in interm ittent sw itching into a $m$ uch $m$ ore conductive state 57. T he exact nature of th is sw itching also rem ains unclear, but there is a strong expectations that the form ation of $m$ etallic lam ents that $m$ ay even be in a ballistic regim e of transport, $m$ ay be relevant to the phenom enon.


Fig. 6. Experim ental setup for $m$ apping local conductance. A FM produces local deform ation of top electrode and underlying organic m . The total conductance of the device is $m$ easured and $m$ apped. (C ourtesy C N.Lau).

Recently, a direct evidence was obtained of the form ation of $\backslash$ hot spots" in the LB $\mathrm{m} s$ that $m$ ay be related to the lam ent grow th through the m im aged w ith the use of A FM currentm apping 58]. The system investigated in this work has been P t/stearic acid (C 18)/T i (Pt/C 18/T i) crossbarm olecular structure, consisting of planar $P t$ and $T$ ielectrodes sandw iching a m onolayer of $2.6-\mathrm{nm}$-long stearic acid (C 18H 360 H ) m olecules with typical zero-bias resistance in excess of $10^{5}$. The devices has been sw itched reversibly and repeatedly to higher (\on") or lower (\○ ") conductance states by applying su ciently large bias voltage $V_{b}$ to top $T$ ielectrode $w$ ith regards to $P$ t counterelectrode, Fig.6.

Interestingly, reversible sw itching w as not observed in sym m etric P t/C 18/P t devices. The local conductance $m$ aps of the $\mathrm{Pt} / \mathrm{C} 18 / \mathrm{T}$ i structure have been constructed by using an AFM tip and sim ultaneously m easuring the current through the m olecular junction biased to $V_{b}=0: 1 \mathrm{~V}$ (AFM tip was not used as an electrode, only to apply local pressure at the surface). T he study revealed that the lm showed pronounced switching between electrically very distinct states, w ith zero-bias conductances 0:17 S (\o " state) and 1.45 S ( $\backslash o n$ " state), F ig. 7 .

At every sw itching \on" there appeared a local conductance peak on the m ap w ith a typicaldiam eter 40 nm , which then disappeared upon sw itching \o ", Fig. 7 (top inset). T he sw itching hasbeen attributed to localconducting lam ent form ation due to electrom igration processes. It rem ains unclear how exactly the lam ents dissolve under opposite bias voltage, why they tend to appear in new places after each sw itching, and why conductance in some cases strongly depends on tem perature. It is clear, how ever, that sw itching in such a sim ple molecule w thout any redox centers, m obile groups, or charge reception centers should be extrinsic. Interestingly, very sim ilar \sw itching" betw een tw o resistive states has also been observed for tunneling through thin inorganic perovskite oxide m s 59].


Fig. 7. I-V characteristic show ing the reversible sw itching cycle of the device (bottom inset) with organic m . The arrows indicate sweep direction. A negative bias sw itches the device to a high conductance state, while the positive one sw itches it to low conductance state. The mapping according the schem atic in F ig. 6 show s the appearance of $\backslash$ hot spots" after sw itching (top inset). (C ourtesy C N . Lau).

There have been plenty of reports on non-linear I-V characteristics like negative di erential resistance (NDR) and random switching recently for $m$ olecules assem bled on $m$ etal electrodes ( $g o l d$ ) and silicon. Reports on NDR for $m$ olecules $w$ ith $m$ etal contacts ( $A u, H g$ ) have been $m$ ade in [33, 45, 60]. It becam e very clear though that $m$ ost of these observations are related to $m$ olecular recon gurations and bond breaking and $m$ aking, rather to any intrinsic m echanism, like redox states, speculated about in the originalR ef. [33]. Thus, the NDR in Tour wires was related to m olecular recon guration $w$ th respect to m etallic electrode [22, 34], NDR in ferrocene-tethered alkylm onolayers [60] was found to be related to oxygen dam age at high voltage [61]. Structural changes and bond breaking have been found to result in NDR in experim ents w ith STM [62, 63, 64] and m ercury droplet contacts [65].

Severalm olecules, like styrene, have been studied on degenerate Si surface and showed an NDR behavior [66]. H ow ever, those results have been carefiully
checked later and it was found that the styrenem olecules do not exhibit ND R, but rather sporadically sw itch betw een states w ith di erent current w hile held at the sam e bias voltage (the blinking e ect) [67].

TheSTM m ap of the styrenem olecules (indicated by arrow s ) on the Silicon (100) surface show $s$ that the $m$ olecules are blinking, see $F$ ig. 8. The blinking is absent at clean Si areas, dark (D) and bright (C ) defects. This m ay indicate a dynam ic process occurring during the im aging. C om paring the panel (a) and (b) one $m$ ay see that some molecules are actually decom posing. The height versus voltage spectra over particular points are show in $F$ ig. 8 c . T he featureless curve 1 w as taken over a clean silicon dim er. T he other spectra w ere recorded over individualm olecules. E ach of these spectra have $m$ any sudden decreases and increases in current as if the $m$ olecules are changing betw een di erent states during the $m$ easurem ent causing a change in current and a response of the feedback control, resulting in a change in height so there exists one or $m$ ore con gurations that lead to $m$ easurem ent of a di erent height. Evidently, these changes have the sam e origin as the blinking of $m$ olecules in STM im ages. Figure 8b reveals clear structural changes associated w ith those particular spectroscopic changes. In each case where a dram atic change in spectroscopy occurred, the molecules in the im age have changed from a bright feature to a dark spot. This is interpreted as a decom position of the m olecules. A detailed look at each decom posed styrene m olecule, at locations $3,4,5$, and 6 , show s that the dark spot is not in precise registry w th the original bright feature, indicating that the decom position product involves reaction w ith an adjacent dim er [67].

The fact that the structural changes and related NDR behavior are not associated w ith any resonant tunneling through the m olecular levels or redox processes, but are perhaps related to inelastic electron scattering or other extrinsic processes, becom es evident from current versus tim e records show $n$ in $F$ ig. [9, R ef.[67]. The records show either no change of the current with tim e (1), or one or a few random jum ps between certain current states (telegraph noise). The observed changes in current at a xed voltage obviously cannot be explained by shifting and aligning ofm olecular levels, as was suggested in Ref. [68], they m ust be related to an adsonbate molecule structural changes w ith tim e. T herefore, the explanation by D atta et al that the resonant level alignm ent is responsible for ND R does not apply [68]. A s m entioned above, sim ilar telegraph sw itching and NDR has been observed in Tour wires [34] and other m olecules. T herefore, the observed negative di erential resistance apparently has sim ilar origin in disparate molecules adsorbed on di erent substrates, and has to do $w$ ith m olecular reconform ation/recon guration on the surface.


Fig. 8. STM im ages or styrene molecules on clean $\mathrm{Si}(100)$ before and after spectroscopy over the area 75240 A . (Top left) B ias -2 V , current 0.7 nA . Only the styrene $m$ olecules (indicated by arrow s) are blinking during im aging. The clean Si surface, bright defects ( $m$ arked C), and dark sports ( $m$ arked D ) do not experience blinking. (B ottom left) bias -2 V , current 0.3 nA . STM im age of individual styrene m olecules indicated $w$ ith num bers 2-6. Styrene $m$ olecules $3-6$ have decom posed. D ecom position involves the changing of the styrene $m$ olecule from a bright feature to a dark depression and also involves the reaction $w$ th an adjacent dim er. Styrene m olecule 2 does not decom pose and im ages as usual with no change of position. (R ight) H eight-voltage spectra taken over clean silicon (1) and styrene molecules $(2-6)$. The spectra taken over $m$ olecules show several spikes in height related to blinking in the im ages. In spectra 3-6, an abrupt and perm anent change in height is recorded and is correlated w ith decom position, as seen in the bottom left im age. Spectrum 2 has no perm anent height change, and the $m$ olecule does not decom pose. (C ourtesy J. P itters and R.W olkow ).
4.2 Intrinsic polarization and extrinsic conductance sw itch ing in m olecular ferroelectric P V D F

T he only well established, to the best of our know ledge, intrinsic m olecular SW itching (of polarization, not current) under bias voltage was observed in $m$ olecular ferroelectric block co-polym ens polyvinylidene[69]. Ferroelectric polym er m s have been prepared w ith the 70\% vinylidene uoride copoly$m$ er, P (VDF-TrFE 70:30), form ed by horizontalLB deposition on alum inum coated glass substrates w ith evaporated alum inum top electrodes. T he poly$m$ er chains contain random sequence of $\left(\mathrm{CH}_{2}\right)_{\mathrm{n}}\left(\mathrm{CF}_{2}\right)_{\mathrm{m}}$ blocks, uorine site carries a strong negative charge, and in the ferroelectric phase m ost of carbonuorine bonds point in one direction. T he uorine groups can be rotated and aligned in very strong electric eld, $5 \mathrm{M} \mathrm{V} / \mathrm{cm}$. A s a result, the wholem olecular chain orders, and in this way the m acroscopic polarization can be sw itched betw een the opposite states. The sw itching process is extrem ely slow, how -


Fig. 9. Variation of current through styrene m olecules on $\operatorname{Si}(100)$ w ith tim e. Tunneling conditions were set at -3 V and 0.05 nA . Abrupt increases and decreases in current relate to changes of the m olecule during the spectroscopy. Som e experi$m$ ents show no changes in current (curve 1), others show various kinds of telegraph sw itching. (C ourtesy J.P itters and R.W olkow ).
ever, and takes 1-10 seconds (!) [70, 71]. This is not surprising, given strong C oulomb interaction between charged groups and the $m$ etal electrodes, pinning by surface roughness, and steric hindrance to rotation. This behavior should be suggestive of other sw itching system sbased on one of few monolayers ofm olecules, and other nontrivial behavior involved [71].

The sw itching of current was also observed in m s of PVDF 30 m onolayers thick. The conductance of the m was follow ing the observed hysteresis loop for the polarization, ranging from $\begin{array}{lllllll}1 & 10^{9} & 2 & 10^{6} & { }^{1} & {[72] \text {. The }}\end{array}$ phenom enon of conductance sw itching has these im portant features: (i) It is connected w th the bulk polarization sw itching; (ii) there is a large $1000: 1$ contrast betw een the ON and OFF states; (iii) the ON state is obtained only when the bulk polarization is sw itched in the positive direction; (iv) the conductance sw itching is much faster than the bulk polarization sw itching. The conductance sw itches ON only after the 6 s delay, after the bulk polarization sw itching is nearly com plete, presum ably when the last layer sw itches into
alignm ent with the others, while the conductance sw itches OFF w ithout a notioeable delay after the application of reverse bias as even one layer reverses (this $m$ ay create a barrier to charge transfer). The slow $2 s$ time constant for polarization sw itching is probably nucleation lim ited as has been observed in high-quality bulk m swith low nucleation site densities 731. The duration of the conductance sw itching transition 2 m sm ay be lim ited only by the $m$ uch faster sw itching tim e of individual layers.

The origin of conductance sw itching by 3 orders of $m$ agnitude is not clear. It $m$ ay indeed be related to a changing am ount of disorder for tunneling/hopping electrons. It is conceivable that the carriers are strongly trapped in polaron states inside PVDF and nd optim alpath for hopping in the $m$ aterial, which is incom pletely sw itched. This is an interesting topic that certainly in need of further experim ental and theoretical study.

## 5 M olecular quantum dot sw itching

### 5.1 E lectrically addressable m olecules

For many applications one needs an intrinsic molecular \sw itch", i.e. a bistable voltage-addressable m olecular system $w$ ith very di erent resistances in the two states that can be accessed very quickly. T here is a trade-o betw een the stability of a m olecular state and the ability to sw itch the m olecule betw een two states with an extemal perturbation (we discuss an electric
eld, sw itching involving absorbed photons is im practical at a nanoscale). Indeed, the applied electric eld, on the order of a typical breakdown eld $\mathrm{E}_{\mathrm{b}} \quad 10^{\gamma} \mathrm{V} / \mathrm{cm}$, is m uch sm aller than a typicalatom ic eld $10^{\circ} \mathrm{V} / \mathrm{cm}$, characteristic of the energy barriers. Sm allbarrier w ould be a sub ject for sporadic therm alsw itching, whereas a larger barrier $1 \quad 2 \mathrm{eV}$ would be im possible to overcom ew ith the applied eld. O ne $m$ ay only change the relative energy of them inim a by extemal eld and, therefore, redistribute the m olecules statistically slightly inequivalently betw een the tw o states. A $n$ intrinsic disadvantage of the conform ationalm echanism, involving $m$ otion of ionic group, exceeding the electron $m$ ass by $m$ any orders of $m$ agnitude, is a slow $s w i t c h i n g$ speed ( kHz ). In case of supram olecular com plexes like rotaxanes and catenanes [36] there are two entangled parts which can change m utual positions as a result of redox reactions (in solution). T hus, for the rotaxane-based $m$ em ory devices a slow sw itching speed of $10^{2}$ seconds was reported.

A sa possible conform ationalE - eld addressablem olecular sw itch, we have considered a bistable m olecule w ith $-\mathrm{CONH}_{2}$ dipole group (74]. The barrier height is $\mathrm{E}_{\mathrm{b}}=0: 18 \mathrm{eV}$. Interaction w th an extemal electric eld changes the energy of the $m$ inim a, but estim ated switching eld is huge, $0: 5 \mathrm{~V} / \mathrm{A}$. At non-zero tem peratures, tem perature uctuations $m$ ight result in statistical dipole ipping at lower elds. The I-V curve show s hysteresis in the 3 to 4

(b) Current hysteresis

degenerate molecular QD
e-ph > Coulomb


Fig. 10. Schem atic of the m olecular quantum dot with centralconjugated unit separated from the electrodes by $w$ ide-band insulating $m$ olecular groups. $F$ irst electron tunnels into the dot and occupies an em pty (degenerate) state there. If the interaction betw een the rst and second incom ing electron is repulsive, $U>0$, then the dot willbe in a Coulom b blockade regim e (a). If the electrons on the dot e ectively attract each other, $U<0$, the system $w$ ill show current hysteresis (b).

Volts window for two possible conform ations. O ne can estim ate the therm al stability of the state as 58 ps at room tem perature, and 33 m s at 77 K .

W e explored a possibility for a fast m olecular sw itching where sw itching is due to strong correlation e ects on the $m$ olecule itself, so-called $m$ olecular quantum $\operatorname{dot}(M Q D)$. The m olecular quantum dot consists of a central conjugated unit (containing half-occupied, and, therefore, extended orbitals), Fig. 10. Frequently, those are form ed from the p-states on carbon atom $s$, which are not saturated (i.e. they do not share electrons with other atom s form ing strong bonds, w ith typicalbonding-antibonding energy di erence about 1Ry). Since the orbitals are halfoccupied, they form the HOMOLUMO states. The size of the HOMO-LUMO gap is then directly related to the size of the conjugated region $\mathrm{d}, \mathrm{Fig}$. 10 , by a standard estim ate $\mathrm{E}_{\text {HOMO-LUMO }} \quad \mathrm{h}^{2}=\mathrm{md}^{2} \quad 25 \mathrm{eV}$. It is worth noting that in the conjugated linear polym ens like polyacetylene $(\stackrel{j}{C}=\stackrel{j}{C})_{n}$ the spread of the electron would be $d=1$ and the expected $\mathrm{E}_{\mathrm{H} O \mathrm{M} O-\mathrm{LUM}}=0: \mathrm{H}$ owever, such a one-dim ensional $m$ etal is im possible, $P$ eierls distortion ( $C=C$ bond length dim erization) sets in and opens up a gap of about $1: 5 \mathrm{eV}$ at the Ferm i level[17]. In a m olecular quantum dot the central conjugated part is
separated from electrodes by insulating groups $w$ ith saturated bonds, like e.g. the alkane chains, F ig. 3. N ow, there are tw m ain possibilities for carrier transport through the mollD . If the length of at least one of the insulating groups $L_{1(2)}$ is not very large (a conductance $G_{1(2)}$ is not $m$ uch sm aller than the conductance quantum $\mathrm{G}_{0}=2 \mathrm{e}^{2}=\mathrm{h}$ ), then the transport through the $M Q D$ will proceed by resonant tunneling processes. If, on the other hand, both groups are such that the tunnel conductance $G_{1(2)} \quad G_{0}$; the charge on the dot w ill be quantized. T hen we w ill have another tw o possibilities: (i) the interaction of the extra carriers on the dot is repulsive $U>0$; and we have a Coulom b blockade [75], or (ii) the e ective interaction is attractive, $\mathrm{U}<0$; then we would obtain the current hysteresis and sw itching (see below ). C oulom b blockade in m olecular quantum dots has been dem onstrated in Refs. [76]. In these w orks, and in Ref. [77], the three-term inalactive m olecular devices have been fabricated and successfiully tested.

M uch faster sw itching com pared to the conform ational one, described in the previous section, $m$ ay be caused by coupling to the vibrational degrees of freedom, if the vibron-m ediated attraction betw een two carriers on the m olecule is stronger than their direct C oulom b repulsion [52], F ig. [10b. The attractive energy is the di erence of two large interactions, the C oulom b repulsion and the phonon $m$ ediated attraction, on the order of 1 eV each, hence jJ j $0: 1 e V$.

### 5.2 P olaron m echan ism of carrier attraction and sw itch ing

A though the correlated electron transport through $m$ esoscopic system $s w$ ith repulsive electron-electron interactions received considerable attention in the past, and continues to be the focus of current studies, m uch less has been known about a role of electron-phonon correlations in \m olecular quantum dots" (MQD). Somewhile ago we have proposed a negative U Hubbard $m$ odelofa d-fold degeneratequantum dot 78] and a polaron $m$ odelofresonant tunneling through a m olecule with degenerate level [52]. W e found that the attractive electron correlations caused by any interaction $w$ th in the $m$ olecule could lead to a m olecular switching e ect where I-V characteristics have two branches w ith high and low current at the sam e bias voltage. This prediction hasbeen con $m$ ed and extended further in our theory of correlated transport through degenerate M QDswith a fiull account ofboth the C oulom b repulsion and realistic electron-phonon (e-ph) interactions [52]. W e have shown that while the phonon side-bands signi cantly m odify the shape of hysteretic I-V curves in com parison w ith the negative-U $H$ ubbard $m$ odel, sw itching rem ains robust. It show sup when the e ective interaction ofpolarons is attractive and the state of the dot is multiply degenerate, $d>2$.

F irst, we shall describe a sim plest $m$ odel of a single atom ic level coupled w ith a single one-dim ensionaloscillator using the rst quantization representation for its displacem ent $\times$ [79],


Fig. 11. Two localized electrons at sites 1 and 2 w ith opposite spins shift the equilibrium position of the ion at site 3. A s a result, the tw o electrons attract each other.

$$
\begin{equation*}
H="_{0} \hat{n}+f x \hat{n} \quad \frac{1}{2 M} \frac{@^{2}}{@ x^{2}}+\frac{k x^{2}}{2}: \tag{9}
\end{equation*}
$$

$H$ ere $M$ and $k$ are the oscillatorm ass and the spring constant, $f$ is the interaction force, and $h=c=k_{B}=1$. This $H$ am iltonian is readily diagonalized $w$ ith the exact displacem ent transform ation of the vibration coordinate $x$,

$$
\begin{equation*}
\mathrm{x}=\mathrm{y} \quad \mathrm{nf}=\mathrm{k} \tag{10}
\end{equation*}
$$

to the transform ed H am iltonian w ithout electron-phonon coupling,

$$
\begin{align*}
H & ="_{\mathrm{H}} \quad \frac{1}{2 \mathrm{M}} \frac{@^{2}}{@ \mathrm{y}^{2}}+\frac{\mathrm{ky}}{2}  \tag{11}\\
\mathrm{H} & ="_{0} \quad \mathrm{E}_{\mathrm{p}} ; \tag{12}
\end{align*}
$$

where we used $\hat{\mathrm{n}}^{2}=\hat{\mathrm{n}}$ because of the Fem i-D irac statistics. It describes a sm all polaron at the atom ic level "0 shifted down by the polaron level shift $E_{p}=f^{2}=2 k$, and entirely decoupled from ion vibrations. T he ion vibrates near a new equilibrium position, shifted by $f=k, w$ ith the $\backslash o l d "$ frequency $(k=M)^{1=2}$. A s a result of the localion deform ation, the total energy of the whole system decreases by $\mathrm{E}_{\mathrm{p}}$ since a decrease of the electron energy by $2 \mathrm{E}_{\mathrm{p}}$ overruns an increase of the deform ation energy $\mathrm{E}_{\mathrm{p}}$. N ote that the authors ofR ef. [80] m ade an illegitim ate replacem ent of the square of the occupation num ber operator
$\hat{\mathrm{n}}=\mathrm{c}_{0}^{\mathrm{y}} \mathrm{c}_{0}$ in Eq. (11) by its $\backslash \mathrm{m}$ ean- eld" expression $\hat{\mathrm{n}}^{2}=\mathrm{n}_{0} \hat{\mathrm{n}}$ which contains the average population of a single $m$ olecular level, $n_{0}$, in disagreem ent $w$ ith the exact identity, $\hat{\mathrm{n}}^{2}=\hat{\mathrm{n}}$. This leads to a spurious self-interaction of a single polaron w ith itself [i.e. the term $"="_{0} \quad n_{0} E_{p}$ instead of Eq. (12)], and a resulting non-existent nonlinearity in the rate equation.

Lattice deform ation also strongly a ects the interaction betw een electrons. W hen a short-range deform ation potentialand $m$ oleculare-ph interactions are taken into account together w th the long-range Frohlich interaction, they can overcom e the C oulom b repulsion. T he resulting interaction becom es attractive at a short distance com parable to a lattige constant. The origin of the attractive force betw een tw o sm allpolarons can be readily understood from a sim ilar H olstein-like toy model as above [81], but w ith tw o electrons on neighboring sites 1,2 interacting w ith an ion 3 betw een them , $F$ ig. 11. For generality, we now assum e that the ion is a three-dim ensional oscillator described by a displacem ent vector $u$, rather than by a single-com ponent displacem ent $x$ as in Eq.(1).

The vibration part of the H am iltonian in the m odel is

$$
\begin{equation*}
H_{p h}=\frac{1}{2 M} \frac{@^{2}}{@^{2}}+\frac{\mathrm{ku}^{2}}{2} ; \tag{13}
\end{equation*}
$$

E lectron potential energies due to the C oulom b interaction w ith the ion are about

$$
\begin{equation*}
\mathrm{V}_{1 ; 2}=\mathrm{V}_{0} \quad \mathrm{ur}_{\mathrm{R}_{1 ; 2}} \mathrm{~V}_{0}\left(\mathrm{R}_{1 ; 2}\right) ; \tag{14}
\end{equation*}
$$

where $R_{1(2)}$ is the vector connecting ion site 3 w ith electron 1 (2). Hence, the H am iltonian of the m odel is given by

$$
\begin{equation*}
\mathrm{H}=\mathrm{E}_{\mathrm{a}}\left(\mathrm{H}_{1}+\hat{\mathrm{A}}_{2}\right)+\mathrm{u} \quad{ }_{1}\left(\mathrm{~A}_{1}+\mathrm{E}_{2} \hat{\mathrm{~A}}_{2}\right) \quad \frac{1}{2 \mathrm{M}} \frac{@^{2}}{@ \mathrm{u}^{2}}+\frac{\mathrm{ku}^{2}}{2} ; \tag{15}
\end{equation*}
$$

where $\mathrm{f}_{1 ; 2}=\mathrm{Z} \mathrm{e}^{2} \mathrm{e}_{1 ; 2}=\mathrm{a}^{2}$ is the C oulom b force, and $\mathrm{A}_{1 ; 2}$ are occupation num ber operators at every site. This H am iltonian is also readily diagonalized by the sam e displacem ent transform ation of the vibronic coordinate $u$ as above,

$$
\begin{equation*}
\mathrm{u}=\mathrm{v} \quad\left(\mathrm{f}_{1} \mathrm{~A}_{1}+\mathrm{f}_{2} \hat{\mathrm{n}}_{2}\right)=\mathrm{k}: \tag{16}
\end{equation*}
$$

The transform ed H am iltonian has no electron-phonon coupling,

$$
\mathrm{H}=\left(\begin{array}{ll}
\mathrm{O}_{0} & \mathrm{E}_{\mathrm{p}} \tag{17}
\end{array}\right)\left(\hat{\mathrm{r}}_{1}+\hat{\mathrm{A}}_{2}\right)+\mathrm{V}_{\mathrm{ph}} \hat{\mathrm{~A}}_{1} \hat{\mathrm{~A}}_{2} \quad \frac{1}{2 \mathrm{M}} \frac{@^{2}}{@ \mathrm{v}^{2}}+\frac{\mathrm{kv}^{2}}{2} ;
$$

and it describes tw o sm allpolarons at their atom ic levels shifted by the polaron level shiff $E_{p}=f_{1 ; 2}^{2}=2 k$, which are entirely decoupled from ion vibrations. As a result, the lattice deform ation caused by two electrons leads to an e ective interaction betw een them, $\mathrm{V}_{\mathrm{ph}}$, which should be added to their C oulom b repulsion, $\mathrm{V}_{\mathrm{c}}$,

$$
\begin{equation*}
V_{\mathrm{ph}}=\frac{f}{f} \quad{ }_{2} \mathrm{k}: \tag{18}
\end{equation*}
$$

W hen $\mathrm{V}_{\mathrm{ph}}$ is negative and larger by m agnitude than the positive $\mathrm{V}_{\mathrm{c}}$; the resulting interaction becom es attractive. That is $V_{p h}$ rather than $E_{p}$, which is responsible for the hysteretic behavior of M Q D s, as discussed below .

### 5.3 E xact solution

T he procedure, which fully accounts for all correlations in M QD is as follow $S$, see $R$ ef. [52]. Them olecular $H$ am iltonian includes the $C$ oulom brepulsion, $\mathrm{U}^{\mathrm{C}}$, and the electron-vibron interaction as

$$
\begin{align*}
& H={ }^{X} \quad \text { " } \hat{\mathrm{A}}+\frac{1}{2}_{\mathrm{E}}^{\mathrm{X}} \mathrm{U}^{\mathrm{C}} \text { ôn } \hat{\mathrm{n}} \text { 。 } \\
& +{ }^{X} \hat{n}!{ }_{q}\left({ }_{q} d_{q}+H: C:\right)+{ }^{X} \quad!_{q}\left(d_{q}^{y} d_{q}+1=2\right):  \tag{19}\\
& \text {;q } \\
& \text { q }
\end{align*}
$$

$H$ ere $d_{q}$ annihilates phonons, ${ }_{q}$ is the phonon (vibron) frequency, and $q_{q}$ are the e-ph coupling constant ( $q$ enum erates the vibron $m$ odes). T his H am iltonian conserves the occupation num bers of m olecular states f .

O ne can apply the canonical unitary transform ation $e^{S}$, w ith

$$
\begin{aligned}
& S=\quad \hat{\mathrm{n}}\left(\mathrm{qd}_{\mathrm{q}} \quad \mathrm{H}: \mathrm{C}:\right) \\
& \text { q; }
\end{aligned}
$$

integrating phonons out. The electron and phonon operators are transform ed as

$$
e=c X ; \quad X=\exp \quad \begin{aligned}
& X \\
& q d_{q} \quad H: c: ~
\end{aligned}
$$

(20)
and

$$
\begin{equation*}
\tilde{a}_{\mathrm{q}}=\mathrm{d}_{\mathrm{q}} \quad \hat{\mathrm{n}} \quad \hat{\mathrm{n}} \text {; } \tag{21}
\end{equation*}
$$

respectively. This Lang $F$ irsov transform ation shiffs ions to new equilibrium positions $w$ ith no e ect on the phonon frequencies. The diagonalization is exact:

$$
\begin{equation*}
\tilde{H}=\mathrm{X}_{\mathrm{i}}^{\mathrm{X}} \hat{\mathrm{n}}+{ }_{q}^{\mathrm{X}}!_{q}\left(\mathrm{~d}_{\mathrm{q}}^{\mathrm{y}} \mathrm{~d}_{\mathrm{q}}+1=2\right)+\frac{1}{2}_{\hat{X}}^{\mathrm{X}} \mathrm{U} \text { of } \hat{\mathrm{n}} 0 \text {; } \tag{22}
\end{equation*}
$$

where

$$
\begin{equation*}
\mathrm{U} \quad \circ \quad U^{\mathrm{C}} \circ \quad 2_{\mathrm{q}}^{\mathrm{X}} \quad \mathrm{q} \quad{ }^{\circ} \mathrm{q}!\mathrm{q} ; \tag{23}
\end{equation*}
$$

is the renorm alized interaction of polarons com prising their interaction via $m$ olecular deform ations (vibrons) and the original C oulombrepulsion, $\mathrm{U}^{\mathrm{C}}{ }_{0}$. $T$ he $m$ olecular energy levels are shifted by the polaron level-shift due to the deform ation created by the polaron,

$$
{ }_{q} \mathrm{~J}_{\mathrm{q}} \mathrm{~J}^{2}!_{q}:
$$

(24)

If we assum e that the coupling to the leads is weak, so that the levelw idth jJ ; we can nd the current from [82]

$$
\begin{align*}
I(V) & =I_{0}{ }^{Z} d!\left[f_{1}(!) \quad f_{2}(!)\right] \quad(!) ; \\
(!) & =\underline{1}^{\frac{1}{X}} \operatorname{Im} \hat{G}^{R}(!) ;
\end{align*}
$$

where $j i$ is a complete set of one-particle molecular states, $f_{1(2)}(!)=$ $\exp \frac{!+\mathrm{eV}=2}{\mathrm{~T}}+1^{1}$ the Ferm i function. H ere $\mathrm{I}_{0}=\mathrm{q} ;(!)$ is the m olecular DOS, $\hat{G}^{R}(!)$ is the Fourier transform of the $G$ reen's function $\hat{G}^{R}(t)=$
 ( t ) $=1$ fort $>0$ and zero otherw ise. W e calculate (! ) exactly for the H am iltonian (22), which includes both the Coulom b $U^{C}$ and e-ph interactions.
$T$ he retarded G F becom es

$$
\left.\begin{array}{rl}
G^{R}(t)= & i(t)\left[\begin{array}{llll}
c & (t) c^{y} & X & (t) X^{y} \\
& +c^{y} c & \text { (t) } & X^{y} X
\end{array}\right. \\
\text { (t) }) \tag{27}
\end{array}\right]: \$ ~ l
$$

The phonon correlator is sim ply

$$
\begin{array}{r}
X \quad(t) X^{y}=\exp _{q}^{X} \frac{j q^{3}}{\sinh \frac{!_{q}}{2}} \\
\cos !t+i \frac{!_{q}}{2} \quad \cosh \frac{!_{q}}{2} ; \tag{28}
\end{array}
$$

where the inverse tem perature $=1=T$, and $X{ }^{\mathrm{Y} X} \quad$ ( t$)=\mathrm{X} \quad(\mathrm{t}) \mathrm{X}^{\mathrm{Y}}$ : The rem aining GFs $c(t) c^{y}$, are found from the equations of $m$ otion exactly. Finally, for the sim plest case of a coupling to a single $m$ ode $w$ th the characteristic frequency ! o and q we nd \$2]
where

$$
\begin{align*}
& G^{R}(!)=Z{ }_{r=0}^{X^{1}} C_{r}(n)^{X^{1}} I_{1}()^{\prime} \\
& e^{\frac{!01}{2}} \frac{1}{!} \begin{array}{rl}
n U & n \\
! & n \\
! & n U+1!_{0}+i
\end{array} \\
& +\left(\begin{array}{ll}
1 & 10
\end{array}\right) e^{\frac{!01}{2}} \\
& \frac{1 \mathrm{n}}{!} \mathrm{rU}+1!_{0}+i \quad+\frac{\mathrm{n}}{!} \quad \mathrm{rU} \mathrm{l}+\mathrm{i}+ \tag{29}
\end{align*}
$$

$$
z=\exp \quad \begin{align*}
& \mathrm{j}  \tag{30}\\
& \mathrm{j} \\
& \mathrm{~J} \\
& j \\
& \operatorname{coth} \frac{!_{q}}{2}
\end{align*}
$$

is the fam iliar polaron narrow ing factor, the degeneracy factor

$$
\begin{equation*}
C_{r}(n)=\frac{(d \quad 1)!}{r!(d \quad 1 \quad r)!} n^{r}(1 \quad n)^{d 1 r} ; \tag{31}
\end{equation*}
$$

$=j{ }_{j}=\sinh \frac{!_{0}}{2} ; I_{l}()$ the $m$ odi ed Bessel function, and $l k$ the $K$ roneker sym bol. The im portant feature of the D O S, Eq. (25), is its nonlinear dependence on the occupation num ber n : It contains fill inform ation about all possible correlation and inelastic e ects in transport, in particular, all the phonon sidebands.

To sim plify our discussion, we assum e that the C oulom b integrals do not depend on the orbital index, i.e. $U \quad 0=U$, and consider a coupling to a single vibrationalm ode, $!_{q}=!0$. A pplying the sam e transform ation to the retarded G reen's function, one obtains the exact spectral function [52] for a d fold degenerate M QD (i.e. the density ofm olecular states, D O S) as

$$
\begin{align*}
& (!)=Z_{r=0}^{X^{1}} C_{r}(n)^{X^{1}} I_{l}(\quad) \\
& \left.e^{!0 l=2}\left[\begin{array}{llll}
(1 & n
\end{array}\right) \quad\left(\begin{array}{ll}
! & r U \\
b!
\end{array}\right)+n \quad(!\quad r U+1.6)\right] \\
& +\left(\begin{array}{ll}
1 & 10
\end{array}\right) \mathrm{e}^{!0_{0} l=2} \text { nn } \quad\left(\begin{array}{lll}
! & \mathrm{rU} & \left.I_{d}\right)
\end{array}\right. \\
& \left.+\left(\begin{array}{ll}
1 & \mathrm{n})
\end{array} \text { (! } \mathrm{r} U+I_{d}\right)\right] \text {; } \tag{32}
\end{align*}
$$

h
i
where $Z=\exp j$ jooth $\frac{!0}{2}$, is the above polaron narrow ing factor, $=$ j $\mathcal{J}=\sinh \left(!_{0}=2\right) ; \quad=1=T$, and $1 k$ the $K$ roneker sym bol.

The im portant feature of DOS, Eq. (32), is its nonlinear dependence on the average electronic population $n=c^{y} C$; which leads to the $s w$ itching, hysteresis, and other nonlineare ects in $I-V$ characteristics for $d>2$ [52]. It appears due to correlations betw een di erent electronic states via the correlation coe cients $C_{r}(n)$. T here is no nonlinearity if the dot is nondegenerate, $d=1$; since $C_{0}(n)=1$. In this simple case the DOS, Eq. (32), is a linear function of the average population that can be found as a textbook exam ple of an exactly solvable problem s [83].

In the present case of $M Q D$ weakly coupled with leads, one can apply the Ferm i-D irac golden rule to obtain an equation for $n$ : Equating incom ing and outgoing num bers of electrons in $M Q D$ per unit tim e we obtain the selfconsistent equation for the leveloccupation $n$ as

$$
\begin{align*}
& \left(\begin{array}{ll}
1 & n
\end{array}{ }_{1} d!f_{1} f_{1}(!)+{ }_{2} f_{2}(!) g(!)\right. \\
& Z_{1} \tag{33}
\end{align*}
$$

where 1 (2) are the transition rates from left (right) leads to M Q D, and (!) is found from Eqs. (29) and (25). For $d=1 ; 2$ the kinetic equation for $n$ is linear, and the sw itching is absent. Sw itching appears for $d{ }_{R_{1}} 3$; when the kinetic equation becom es non-linear. Taking into account that $R_{1} \quad(!)=d$, Eq. (33) for the sym m etric leads, $1=2$; reduces to

$$
\begin{equation*}
2 n d=d!\quad(!)\left(f_{1}+f_{2}\right) ; \tag{34}
\end{equation*}
$$

which autom atically satis es 0 n 1.Explicitly, the self-consistent equation for the occupation num ber is

$$
\begin{equation*}
n=\frac{1}{2}_{r=0}^{\mathbb{X}^{1}} C_{r}(n)\left[n a_{r}^{+}+(1 \quad n) d_{r}^{+}\right] \tag{35}
\end{equation*}
$$

where

$$
\begin{align*}
a_{r}^{+}= & Z^{X^{1}} I_{1}() e^{\frac{!_{01}}{2}}\left[f_{1}\left(r U \quad l!_{0}\right)+f_{2}\left(r U \quad l!_{0}\right)\right] \\
& +(1 \quad 10) e^{\frac{!_{01}}{2}\left[f_{1}\left(r U+1!_{0}\right)+f_{2}\left(r U+l!_{0}\right)\right] ;}  \tag{36}\\
b_{r}^{+}= & Z^{X^{1}} I_{1}() e^{\frac{!_{01}}{2}}\left[f_{1}\left(r U+1!_{0}\right)+f_{2}\left(r U+l!_{0}\right)\right] \\
& +(1 \quad 10) e^{\frac{!_{01}}{2}}\left[f_{1}\left(r U \quad l!_{0}\right)+f_{2}\left(r U \quad l!_{0}\right)\right]: \tag{37}
\end{align*}
$$

T he current is expressed as

$$
\begin{equation*}
j \quad \frac{I(V)}{d I_{0}}=X_{r=0}^{1} Z_{r}(n)\left[n a_{r}+(1 \quad n) b\right] ; \tag{38}
\end{equation*}
$$

where

$$
\begin{align*}
& +(1 \quad 10) e^{\frac{!!_{01}}{2}}\left[f_{1}\left(r U+1!_{0}\right) \quad f_{2}\left(r U+1!_{0}\right)\right] \text {; }  \tag{39}\\
& b_{r}=Z_{l=0}^{X^{Z}} I_{l}() e^{\frac{!_{01}}{2}}\left[\mathrm{I}_{1}\left(r \mathrm{U}+\mathrm{l}!_{0}\right) \quad \mathrm{f}_{2}\left(\mathrm{rU}+\mathrm{l}!_{0}\right)\right]
\end{align*}
$$



F ig. 12. C urrent-voltage characteristic of the nondegenerate $(\mathrm{d}=1) \mathrm{MQD}$ at $\mathrm{T}=0$; $!_{0}=0: 2$, and ${ }^{2}=11=13$. There is the phonon ladder in $I-V$, but no hysteresis.
5.4 Absence of sw itching of single- or double-degenerate M Q D

If the transition rates from electrodes to M Q D are small, ! 0 , the rate equation for $n$ and the current, $I(V)$ are readily obtained by using the exact m olecular D O S , Eq. (32) and the Ferm i-D irac G olden rule. In particular, for the nondegenerate $M Q D$ and $T=O K$ the result is

$$
\begin{equation*}
\mathrm{n}=\frac{\mathrm{b}_{0}^{+}}{2+\mathrm{b}_{0}^{+} \quad \mathrm{o}_{0}^{+}} \tag{41}
\end{equation*}
$$

and

$$
\begin{equation*}
j=\frac{2 b_{0}+a_{0} b_{0}^{+} \quad a_{0}^{+} b_{0}}{2+b_{0}^{+}} a_{0}^{+}, \tag{42}
\end{equation*}
$$

T he generalexpressions for the coe cients are given at arbitrary tem peratures in Ref. [52], and they are especially sim ple in low tem perature lim it:


Fig. 13. C urrent-voltage characteristic of two-fold degenerate M Q D s ( $\mathrm{d}=2$ ) does not show hysteretic behavior. The param eters are the same as in F ig. 12. Larger num ber of elem entary processes for conductance com pared to the nondegenerate case of $d=1$ generates $m$ ore steps in the phonon ladder in com parison $w$ ith F ig. 12 .

$$
\begin{align*}
& a_{0}=Z_{l=0}^{X^{1}} \frac{j\}^{1}}{l!}\left[\left(1!_{0} \quad+e V=2\right)\right. \\
& \text { ( } 1 \text { ! } \quad \mathrm{eV}=2 \text { ) ]; }  \tag{43}\\
& b_{0}=Z^{x^{1}} \frac{j\}^{1}}{l!}[(\quad 1!0 \quad+e V=2) \\
& \text { ( ld eV=2)]; } \tag{44}
\end{align*}
$$

$j=I=I_{0}, I_{0}=e d, \quad$ is the position of the $M Q D$ level $w$ th respect to the Ferm ilevelat V = 0, and (x) = 1 if $x>0$ and zero otherw ise. The current is single valued, F ig. 12 , w ith the fam iliar steps due to phonon-side bands. The double-degenerate level provides $m$ ore elem entary processes for conductance re ected in larger num ber of steps on phonon ladder com pared to $d=2$ case, Fig. 13 .

On the contrary, the $m$ ean- eld approxim ation (M FA) leads to the opposite conclusion. G alperin et al. [80] have replaced the occupation num ber operator $\hat{\mathrm{A}}$ in the e-ph interaction by the average population $\mathrm{n}_{0} \mathbb{E q}$. (2) of Ref. [80]] and found the average steady-state vibronic displacem ent hd $+d^{y}$ i proportional to $n_{0}$ (this is an explicit neglect of all quantum uctuations on the dot accounted for in the exact solution). T hen, replacing the displacem ent operator $d+d^{y}$ in the bare H am iltonian, Eq. (11), by its average, Ref. [80], they obtained a new m olecular level, $\boldsymbol{\mu}_{0}="_{0} \quad 2_{\text {reorg }} \mathrm{n}_{0}$ shifted linearly w ith the average population of the level. This is in stark disagreem ent w ith the conventional constant polaronic level shiff, Eq. (12,24) ("reorg is j $\}$ ! 0 in our notations). The M FA spectral function tumed out to be highly nonlinear as a function of the population, e.g. for the weak-coupling $w$ th the leads
$(!)=\left(!\quad 0^{\prime \prime} \quad 2^{\prime \prime}\right.$ reorg $\left.n_{0}\right)$; see Eq. (17) in Ref. [80]. A s a result, the authors ofR ef.[80] have found $m$ ultiple solutions for the steady-state population, Eq. (15) and Fig. 1, and sw itching, Fig. 4 of R ef. [80], which actually do not exist being an artefact of the $m$ odel.

In the case of a double-degenerate $M Q D, d=2$; there are tw $O$ term $s$, $w$ hich contribute to the sum over $r$, $w$ ith $C_{0}(n)=1 \quad n$ and $C_{1}(n)=n$ :The rate equation becom es a quadratic one [52]. N evertheless there is only one physical root for any tem perature and voltage, and the current is also single-valued, Fig. 3.
$N$ ote that the $m$ ean- eld solution by $G$ alperin et al. [80] applies at any ratio $=!_{0}$; including the lim it of interest to us, $\quad!_{0}:$ where their transition betw een the states $w$ th $n_{0}=0$ and 1 only sharpens, but none of the results change. Therefore, M FA predicts a current bistability in the system where it does not exist at $d=1:$ Ref. [80] plots the results for $!_{0}$; $0: 1 \quad 0: 3$ eV , which corresponds to $m$ olecular bridges $w$ th a resistance of about a few 100 k : Such model \m olecules" are rather \m etallic" in their conductance and could hardly show any bistability at allbecause carriers do not have tim e to interact $w$ th vibrons on the $m$ olecule. Indeed, taking into account the coupling w th the leads beyond the second order and the coupling between the m olecular and bath phonons could hardly provide any non-linearity because these couplings do not depend on the electron population. This rather obvious conclusion form olecules strongly coupled to the electrodes can be reached in $m$ any ways, see e.g. a derivation in Refs. [84, 85]. W hile Refs. 84, 85] do talk about telegraph current noise in the $m$ odel, there is no hysteresis in the adiabatic regime, $\quad!_{0}$ ether. This result certainly has nothing to do $w$ ith ourm echanism of sw itching (52] that applies to $m$ olecular quantum dots ( $\quad!_{0}$ ) with $d>2$ : Such regim e has not been studied in Refs. [84, 85, 86], which have applied the adiabatic approxim ation, as being \too challenging problem ". N evertheless, M itra et al. [86] have $m$ isrepresented our form alism [52] claim ing that it \lacks of renorm anlization of the dot-lead coupling" (due to electron-vibron interaction), or \treats it in an average $m$ anner". In fact, the form alism [52] is exact, fully taking into account the polaronic renor-
$m$ alization, phonon-side bands and polaron-polaron correlations in the exact m olecular D O S, Eq. (32).

A s a $m$ atter of fact, $m$ ost of the $m$ olecules are very resistive, so the actual m olecular quantum dots are in the regim e we study, see Ref. 87]. For exam ple, the resistance of fully con jugated three-phenyl ring Tour-R eed m olecules chem ically bonded to $m$ etallic A u electrodes [33] exceeds 1G. Therefore, $m$ ost of the $m$ olecules of interest to us are in the regim e that we discussed, not that of $R$ efs. [84, 85].

### 5.5 N on linear rate equation and sw itch ing

$N$ ow, consider the case $d=4$, where the rate equation is non-linear, to see if it producesm ultiple physicalsolutions. For instance, in the lim it $j j 1 ; T=0$; where we have $b_{r}=a_{r}, Z=1$; the rem aining interaction is $U=U^{C}<0$, we recover the negative U m odel 78 , and the kinetic equation for $\mathrm{d}=4$ is

$$
\begin{equation*}
2 \mathrm{n}=1 \quad(1 \quad \mathrm{n})^{3} \tag{45}
\end{equation*}
$$

in the voltage range $j \mathrm{j} j<\mathrm{eV} \overline{\overline{\mathrm{p}}}{ }_{2}<$. This equation has an additional nontrivialphysicalsolution $n=(3 \quad \overline{5})=2=0: 38$. The current is sim pli ed as $\mathrm{I}=\mathrm{I}_{0}=2 \mathrm{n}: T$ he current-voltage characteristics w ill show a hysteretic behavior in this case for $d=4: W$ hen the voltage increases from zero, 4-fold degenerate $M Q D$ rem ains in a low -current state until the threshold $\mathrm{eV}_{2}=2=$ is reached. Rem arkably, when the voltage decreases from the value above the threshold $V_{2}$, them olecule rem ains in the high-current state dow $n$ to the voltage $\mathrm{eV}_{1}=2=$
ju jwell below the threshold $V_{2}$.
In fact, there is a hysteresis of current at all values of the electron-phonon constant ; e.g. ${ }^{2}=11=13$ (selected in order to avoid an accidental com $m$ ensurability of ! 0 and U ), Fig. 14. Indeed, the exact equation for average occupation of the dot reads

$$
\begin{align*}
& 2 \mathrm{n}=\left(\begin{array}{ll}
1 & \mathrm{n}
\end{array}\right)^{3}\left[\begin{array}{ll}
\left.\mathrm{n} a_{0}^{+}+\left(\begin{array}{ll}
1 & \mathrm{n}
\end{array}\right){ }^{+}\right]
\end{array}\right] \\
& +3 n(1 \quad n)^{2}\left[n a_{1}^{+}+\left(\begin{array}{ll}
1 & n
\end{array}\right){ }^{+}\right] \\
& +3 n^{2}(1 \quad n)\left[n_{2}^{+}+\left(\begin{array}{ll}
1 & n
\end{array}\right){ }_{2}^{+}\right] \\
& +n^{3}\left[n_{3}^{+}+(1 \quad n) l_{3}^{+}\right]: \tag{46}
\end{align*}
$$

W e solved this nonlinear equation for the case $!_{0}==0.2 ; \mathrm{U}^{\mathrm{C}}=0$; so that the attraction betw een electrons is $U=2^{2}!_{0}=0: 4$ (all energies are in units of ), and found an additional stable solution for an average occupation num ber (and current) that results in a hysteresis curve, Fig. 14. T he bistability region shrinks dow $n$ w ith tem perature, and the hysteresis loop practically closes at $T==0: 01$. A s we see from Eqs. (36), (37), the electron levels $w$ ith phonon sidebands $\quad 1!_{0 ;}+U \quad 1!_{0 ;}+2 \mathrm{U} \quad 1!_{0 ;}+3 \mathrm{U} \quad 1!0_{0}$ w ith $l=0 ; 1 ;::$ contribute to electron transport $w$ ith di erent $w$ eights, and this creates a com plex picture of steps on the I-V curve, $F$ ig. (14.


F ig.14. The $I-V$ curves for tunneling through the $m$ olecular quantum dot, Fig . 10b w ith the electron-vibron coupling constant ${ }^{2}=11=13$.

N ote that sw itching required a degenerate M QD (d > 2) and the weak coupling to the electrodes, $\quad!_{0}: \mathrm{D}$ i erent from the non-degenerate dot, the rate equation for a multi-degenerate dot, $d>2$, weakly coupled to the leads has multiple physical roots in a certain voltage range and a hysteretic behavior due to correlations betw een di erent electronic states of M Q D 52].

Sum $m$ arizing this Section, we have calculated the $I-V$ characteristics of the nondegenerate and tw o-fold degenerate M Q D s show ing no hysteretic behavior, and conclude that $m$ ean eld approxim ation [80] leads to a non-existent hysteresis in a m odel that was solved exactly in Ref. [52]. D i erent from the non-degenerate and two-fold degenerate dots, the rate equation for a $\mathrm{m} u l t i-$ degenerate dot, $d>2$, w eakly coupled to the leads, hasm ultiple physicalroots in a certain voltage range show ing hysteretic behavior due to correlations betw een di erent electronic states of Q Q [52]. O ur conclusions are im portant for searching of the current-controlled polaronic m olecular sw itches. Incidentally, $C_{60} \mathrm{~m}$ olecules have the degeneracy $d=6$ of the lowest unoccupied level, which $m$ akes them one of the $m$ ost prom ising candidate system $s$, if the w eak-coupling w ith leads is secured.

## 6 R ole of defects in m olecular transport

Interesting behavior of electron transport in $m$ olecular system $s$, as described above, refers to ideal system $s$ w thout im perfection in ordering and composition. In reality, one expects that there $w$ ill be a considerable disorder and defects in organic molecular m s. As mentioned above, the conduction through absorbed [54] and Langm uir-B lodgett [55] m onolayers of fatty acids ( $\left.\mathrm{CH}_{2}\right)_{\mathrm{n}}$ was associated with defects. An absence of tunneling through selfassem bled m onolayers of C 12-C 18 (inferred from an absence of thickness dependence at room tem perature) has been reported by B oulas et al. 533. O n the other hand, the tunneling in alkanethiol SAM S w as reported in [88, 89], $w$ ith an exponential dependence ofm onolayer resistance on the chain length $\mathrm{L}, \mathrm{R} / \exp (\mathrm{L})$; and no tem perature dependence of the conductance in $\mathrm{C} 8-\mathrm{C} 16 \mathrm{~m}$ olecules w as observed over the tem peratures $\mathrm{T}=80 \quad 300 \mathrm{~K}$ 89].

The electrons in alkane $m$ olecules are tightly bound to the $C$ atom $s$ by
bonds, and the band gap (betw een the highest occupied m olecular onbital, H OM O , and low est unoccupied m olecular orbital, LUM O) is large, 9 10eV [53]. In conjugated system $s$ w ith electrons the $m$ olecular orbitals are extended, and the HOMO-LUMO gap is correspondingly sm aller, as in e.g. polythiophenes, where the resistance was also found to scale exponentially with the length of the chain, $R / \exp (L)$; $w$ ith $=0: 35 A^{1}$ instead of
$=1: 08 \mathrm{~A}^{1}$ [88]. In stark contrast w ith the tem perature-independent tunneling results for SAM s [89], recent extensive studies of electron transport through 2.8 nm thick eicosanoic acid (C 20) LB monolayers at tem peratures $2 \mathrm{~K}-300 \mathrm{~K}$ have established that the current is practically tem perature inde-


Fig.15. Localdensity ofstates and transm ission as a function ofenergy for (a) C 13 with Au impurity and (b) C 13 w ith $\mathrm{A} u$ im purity and H vacancy (dangling bond). $M$ iddle sections show closeups of the resonant peaks due to deep defect levels w ith respect to the HOMO and LUM O m olecular states. The HOMO LUMO gap is about 10 eV .
pendent below T < 60 K , but very strongly tem perature dependent at higher tem peratures $\mathrm{T}=60$ 300K 90 ].

A large am ount of e ort went into characterizing the organic thin ms and possible defects there [18, 91, 92]. It has been found that the electrode $m$ aterial, like gold, gets into the body of the $m$, leading to the possibility of $m$ etal ions existing in the lm as single im purities and chisters. Electronic states on these im purity ions are available for the resonant tunneling of carriers in very thin ms (or hopping in thicker m s , a crossover between the regim es depending on the thickness). D epending on the density of the im purity states, $w$ ith increasing $m$ thickness the tunneling $w$ ill be assisted by im purity \chains", w ith an increasing num ber of equidistant im purities [93].

O ne-im purity channels produce steps on the $I-V$ curve but no tem perature dependence, whereas the inelastic tunneling through pairs of im purities at low tem peratures de nes the tem perature dependence of the lm conductance, $G(T) / T^{4=3}$; and the voltage dependence of current $I(V) / V^{7=3}$ [94]. This behavior has been predicted theoretically and observed experim entally for tunneling through am onphous Si [95] and $\mathrm{Al}_{2} \mathrm{O}_{3}$ [96]. D ue to the inevitable disorder in a \soft" m atrix, the resonant states on di erent im purities $w$ ithin a \channel" w illbe random ly m oving in and out of resonance, creating m esoscopic uctuations of the I-V curve. T he tunneling $m$ ay be accom panied by interaction with vibrons on the m olecule, causing step-like features on the I-V curve [77, 52].

D uring processing, especially top electrode deposition, sm all clusters of the electrode $m$ aterial $m$ ay form in the organic $l m$, causing $C$ oulom b blockade, which also can show up as steps on the $I-V$ curve. It has long been know $n$ that a strong applied eld can cause localized dam age to thin m s , presum ably due to electrom igration and the form ation of conducting lam ents [56]. The dam aged area was about 30 nm in diam eter in $40-160 \mathrm{~m}$ onolayer thick LB mm [56] (a) and 5-10 m in diam eter in $\mathrm{m} \mathrm{s} 500-5000 \mathrm{~A}$ thick, and showed sw itching behavior under extemal bias voltage cycling [56] (b). A s discussed above, recent spatial m apping of a conductance in LB m onolayers of fatic acids w th the use of conducting AFM has revealed dam age areas $30-100 \mathrm{~nm}$ in diam eter, frequently appearing in sam ples after a \soft" electricalbreakdown, which is som etim es accom panied by a strong tem perature dependence of the conductance through the lm [58].

A crossover from tunneling at low tem peratures to an activation-like dependence at higher tem peratures is expected for electron transport through organicm olecular $\mathrm{lm} s$. There are recent reports about such a crossover in individualm olecules like the 2 nm long Tour wire w ith a sm allactivation energy $\mathrm{E}_{\mathrm{a}} \quad 130 \mathrm{~m} \mathrm{eV}$ 971. Very sm allactivation energies on the order of $10-100 \mathrm{meV}$ have been observed in polythiophenem onolayers [98]. O ur present results suggest that this $m$ ay be a result of interplay betw een the drastic renorm alization of the electronic structure of the $m$ olecule in contact $w$ ith electrodes, and disorder in the m ( Fig . 16 , right inset). W e report the ab -initio calculations of point-defect assisted tunneling through alkanedithiols $S\left(\mathrm{CH}_{2}\right)_{\mathrm{n}} \mathrm{S}$ and thiophene T 3 (three rings $\mathrm{SC}_{4}$ ) self-assem bled on gold electrodes. The length of the alkane chain was in the range $\mathrm{n}=9 \quad 15$.

W e have studied single and double defects in the m : (i) single Au im purity, Figs. 10a,11a, (ii) Au impurity and H vacancy (dangling bond) on the chain, Figs. 16b, 15k, (iii) a pair of Au im purities, Fig. 15b, (iv) Au and a \kink" on the chain (one $\mathrm{C}=\mathrm{C}$ bond instead of a $\mathrm{C}-\mathrm{C}$ bond). Single defect states result in steps on the associated I-V curve, whereas m olecules in the presence of two defects generally exhibit a negative di erential resistance (NDR). B oth types of behavior are generic and $m$ ay be relevant to som e observed unusual transport characteristics of SAM s and LB ms [54, 55, 58, 90, 97, 98]. W e have used an ab-initio approach that com bines
the K eldysh non-equilibrium G reen's function (NEGF) m ethod with selfconsistent pseudopotential-based real space density functional theory (D FT ) for system s w ith open boundary conditions provided by sem i-in nite electrodes under extemal bias voltage [51, 49]. A 11 present structures have been relaxed w th the G aussian 98 code prior to transport calculations [99]. T he conductance of the system at a given energy is found from Eq. (8) and the current from Eq. (4).

The equilibrium position of an $A u$ im purity is about $3 A$ aw ay from the alkane chain, which is a typical $V$ an-der $W$ aals distance. A s the density $m$ aps show ( $F$ ig. 16), there is an appreciable hybridization betw een the $s$ - and dstates of $A u$ and the sp-states of the carbohydrate chain. Furtherm ore, the $\mathrm{Au}^{+}$ion produces a C oulom b center trapping a 6 s electron state at an energy $i=0: 35 \mathrm{eV}$ w ith respect to the Ferm i level, alm ost in the $m$ iddle of the HOMO LUMO 10 eV gap in Cn . The tunneling evanescent resonant state is a superposition of the HOMO and LUMO m olecular orbitals. Those orbitals have a very com plex spatial structure, re ected in an asym $m$ etric line shape for the transm ission. Since the im purity levels are very deep, they $m$ ay be understood within the m odel of \short-range im purity potential" 100]. Indeed, the im purity wave function outside of the narrow well can be fairly approxim ated as

$$
\begin{equation*}
(r)=\frac{r}{2} \frac{e^{r}}{r} \tag{47}
\end{equation*}
$$

where is the inverse radius of the state, $h^{2}{ }^{2}=2 m=E_{i}$; where $E_{i}=\quad i$ is the depth of the im purity levelw ith respect to the LUMO, and =LUMO F is the distance betw een the LUM O and the Ferm i levelF of gold and, consequently, the radius of the im purity state $1=$ is $s m a l l$. $T$ he energy distance
$4: 8 \mathrm{eV}$ in alkane chains ( $\left.\mathrm{CH}_{2}\right)_{\mathrm{n}}$ [53] ( 5 eV from DFT calculations), and $\mathrm{m} \quad 0: 4$ the e ective tunneling m ass in alkanes[B9]. For one im purity in a rectangular tunnelbarrier [100] we obtain the B reit-W igner form of transm ission $T(E ; V)$, asbefore, $E q$. (5) . U sing the m odelw ith the im purity state wave function (47), we m ay estim ate for an Au im purity in C 13 ( $L=10: 9 \mathrm{~A}$ ) the width $L=R=1: 2 \quad 10^{6}$, which is $w$ ithin an order ofm agnitude com pared w ith the calculated value 1:85 $\quad 10^{5} \mathrm{eV}$. The transm ission is m axim al and equals unity when $E=i$ and $L=R$; which corresponds to a sym $m$ etrical position for the im purity w ith respect to the electrodes.

The electronic structure of the alkane backbone, through which the electron tunnels to an electrode, show s up in the asym $m$ etric lineshape, which is substantially non-Lorentzian, $F$ ig. 15. T he current rem ains sm alluntil the bias has aligned the im purity levelw ith the Ferm ilevel of the electrodes, resulting in a step in the current, $I_{1} \frac{2 q}{h}$ oe ${ }^{L}$ ( $F$ ig. (15a). This step can be observed only when the im purity level is not very far from the Ferm ilevelF; such that biasing the contact can produce alignm ent before a breakdow $n$ of the device $m$ ay occur. The $m$ ost interesting situations that we have found relate to the


Fig. 16. Current-voltage characteristics of an alkane chain C 13 with (a) single Au im purity ( $6 s$-state), (b) two Au impurities ( $5 d$ and $6 s$-states on left and right ions, respectively), and (c) Au im purity and H vacancy (dangling bond). D ouble defects produce the negative di erential resistance peaks (b) and (c). Inset show s the density of states, transm ission, and stick model for polythiophene T 3. T here is signi cant transm ission at the Ferm i level, suggesting an ohm ic I-V characteristic for T 3 connected to gold electrodes. D isorder in the $\mathrm{lm} m$ ay localize states close to the Ferm i level (schem atically m anked by arrow), which $m$ ay assist in hole hopping transport w ith an apparently very low activation energy ( $0.01-0.1 \mathrm{eV}$ ), as is observed.
pairs of point defects in the lm . If the concentration of defects is $c \quad 1$, the relative num ber of con gurations w ith pairs of im purities will be very sm all, $/ c^{2}$ : H ow ever, they give an exponentially larger contribution to the current. Indeed, the optim alposition of tw o im purities is sym m etrical, a distance $\mathrm{L}=2$ apart, $w$ ith current $I_{2} / e^{L=2}: T$ he conductance of a two-im purity chain is [100]

$$
\begin{equation*}
g_{12}(E)=\frac{4 q^{2}}{h} \frac{L R t_{12}^{2}}{j\left(E \quad 1+i_{L}\right)\left(E \quad 2+i_{R}\right) \quad \hbar_{2}^{2} J^{2}}: \tag{48}
\end{equation*}
$$

For a pairofim puritiesw ith slightly di ering energiest $t_{12}=2\left(E_{1}+E_{2}\right) e^{r_{12}}=r_{12}$; where $r_{12}$ is the distance betw een them. The interpretation of the tw o-im purity channel conductance (48) is fairly straightforw ard: if there were no coupling to the electrodes, i.e. $L=R=0$; the poles of $g_{12}$ would coincide $w$ th the bonding and antibonding levels of the tw o-im purity \m olecule". T he coupling to the electrodes gives them a nite width and produces, generally, tw o peaks in conductance, whose relative positions in energy change w ith the bias. T he sam e consideration is valid for longer chains too, and gives an intuitive picture of the form ation of the im purity \band" of states. Them axim al conductivity $g_{12}=q^{2}=h$ occurs when ${ }_{1}=2$; $\mathrm{L} R=\mathrm{t}_{12}^{2}={ }_{2}^{2}$; where 2 is the $w$ idth of the tw o-im purity resonance, and it corresponds to the sym $m$ etricalposition of the im purities along the norm alto the contacts separated by a distance equal to half of the $m$ olecule length, $r_{12}=\mathrm{L}=2: \mathrm{T}$ he im portant property of the tw o-im purity case is that it produces negative di erential resistance (NDR). Indeed, under extemalbias voltage the im purity levels shift as

$$
\begin{equation*}
i=\quad i 0+q V z_{i}=L ; \tag{49}
\end{equation*}
$$

$w$ here $z_{i}$ are the positions of the im purity atom $s$ counted from the center of the m olecule. D ue to disorder in the m , under bias voltage the levels will be moving in and out of resonance, thus producing NDR peaks on the I-V curve. Them ost pronounced negative di erential resistance is presented by a gold im purity next to C n chain w ith an H -vacancy on one site, F ig. .15b (the defect corresponds to a dangling bond). The defects result in two resonant peaks in transm ission. Surprisingly, the H vacancy (dangling bond) has an energy very close to the electrode Ferm ilevelF, with $i=0: 1 e V$ ( $F$ ig 15b, right peak). The relative positions of the resonant peaksm ovew ith an extemal bias and cross at 12 V , producing a pronounced NDR peak in the I-V curve, Fig. 16c. No NDR peak is seen in the case of an Au im purity and a kink $C=C$ on the chain because the energy of the kink level is far from that of the Au 6 s im purity level. T he calculated values of the peak current through the molecules were large: $I_{p} \quad 90 \mathrm{nA} / \mathrm{m}$ olecule for an Au im purity w ith H vacancy, and $5 \mathrm{nA} / \mathrm{m}$ olecule for double Au im purities.
$W$ e have observed a new $m$ echanism for the NDR peak in a situation $w$ ith two Au impurities in the $\mathrm{m} . \mathrm{Nam}$ ely, Au ions produce two sets of deep im purity levels in Cn ms , one stem m ing from the 6 s orbital, another from the 5d shell, as clearly seen in $F$ ig. 16b (inset). T he 5d-states are separated
in energy from 6 s , so that now the tunneling through s -d pairs of states is allow ed in addition to $s$-s tunneling. Since the 5d-states are at a low er energy than the s-state, the $d$ - and s-states on di erent $A u$ ions will be aligned at a certain bias. D ue to the di erent angular character of those orbitals, the tunneling betw een the s-state on the rst im purity and a d-state on another im purity will be described by the hopping integral analogous to the Slater$K$ oster sd integral. The peak current in that case is sm aller than for the pair AuH vacancy, where the overlap is of ss type (cf. Figs.[160,c).

Thiophene m olecules behave very di erently since the states there are conjugated and, consequently, the H OM O -UUM O gap is much narrower, just below 2 eV . The tail of the HOMO state in the T 3 m olecule (w ith three rings) has a signi cant presence near the electrode Ferm i level, resulting in a practically $\backslash m$ etallic" density of states and hence ohm ic I-V characteristic. $T$ his behavior is quite robust and is in apparent disagreem ent $w$ ith experim ent, where tunneling has been observed [88]. H ow ever, in actual thiophene devices the contact betw een the $m$ olecule and electrodes is obviously very poor, and it $m$ ay lead to unusual current paths and tem perature dependence [98].

W e have presented the rst param eter-free DFT calculations of a class of organic $m$ olecular chains inconporating single or double point defects. The results suggest that the present generic defects produce deep im purity levels in the lm and cause a resonant tunneling ofelectrons through the m , strongly dependent on the type of defects. Thus, a m issing hydrogen produces a level (dangling bond) w ith an energy very close to the Ferm i level of the gold electrodes F: In the case of a single im purity, it produces steps on the $I-V$ curve when one electrode's Ferm i level aligns w th the im purity level under a certain bias voltage. The two-defect case is $m$ uch richer, since in this case we generally see a form ation of the negative-di erential resistance peaks. We found that the Au atom together with the hydrogen vacancy (dangling bond) produces the m ost pronounced NDR peak at a bias of 12 V in C 13 . O ther pairs of defects do not produce such spectacular NDR peaks. A short range im purity potentialm odel reproduces the data very well, although the actual lineshape is di erent.
$T$ here is a rem aining question of $w$ hat $m$ ay cause the strong tem perature dependence of conductance in \sim ple" organic $\mathrm{lm} s$ like $\left[\mathrm{CH}_{2} \mathrm{l}_{\mathrm{n}}\right.$. The activation-like conductance / $\exp \left(\mathrm{E}_{\mathrm{a}}=\mathrm{T}\right)$ has been reported w ith a sm all activation energy $\mathrm{E}_{\mathrm{a}} \quad 100 \quad 200 \mathrm{~m} \mathrm{eV}$ in alkanes 90 , 97] and even sm aller, $10-100 \mathrm{~m} \mathrm{eV}$, in polythiophenes [98]. Th is is m uch sm aller than the value calculated here for alkanes and expected from electrical and opticalm easurem ents on $\mathrm{C}_{\mathrm{n}} \mathrm{m}$ olecules, $\mathrm{E}_{\mathrm{a}} \quad 4 \mathrm{eV}$ [53], which correspond nioely to the present results. In conjugated system $s$, how ever, there $m$ ay be rather natural explanation of sm all activation energies. Indeed, the HOMO in T3 polythiophene on gold is dram atically broadened, shifted to higher energies and has a considerable weight at the Ferm i level. The upw ard shift of the HOMO is just a consequence of the work function di erence betw een gold and the molecule. In the presence of (inevitable) disorder in the lm som e of the electronic states
on the m olecules w ill be localized in the vicinity of $\mathrm{E}_{\mathrm{F}}$. T hose states w ill assist the them ally activated hopping of holes w ithin a range of sm all activation energies $0: 1 \mathrm{eV}$. Sim ilar behavior is expected for Tour w ires $\$ 97]$, where $\mathrm{E}_{\mathrm{F}} \quad \mathrm{HOMO} \quad 1$ eV[1] (c), if the electrode-m olecule contact is poor, as is usually the case.

W th regards to carrier hopping in $m$ onolayers of saturated $m$ olecules, one $m$ ay reasonably expect that in $m$ any studied cases the organic 1 m s are riddled $w$ ith $m$ etallic protrusions (lam ents), em erging due to electrom igration in a very strong electric eld, and/orm etallic, hydroxyl, etc. inchusions [56, 58]. It $m$ ay result in a much sm aller tunneling distance $d$ for the carriers and the im age charge low ering of the barrier. T he im age charge low ering of the barrier in a gap of $w$ idth $d$ is $U=q^{2} \ln 4=(d)$; $m$ eaning that a decrease of about 3.5 eV m ay only happen in an unrealistically narrow gap $\mathrm{d}=2$ 3A in a m w ith dielectric constant $=2: 5$; but it w ill add to the barrier low ering. M ore detailed characterization and theoretical studies along these lines $m$ ay help to resolve this very unusual behavior. W e note that such a mechanism cannot explain the crossover w th tem perature from tunneling to hopping reported for single $m$ olecular $m$ easurem ents, which has to be a property of the device, but not a single m olecule 97].

## 7 C onclusions

Studying molecules as possible building blocks for ultradense electronic circuits is a fascinating quest that spans ofover 30 years. It w as inspired decades ago by the notion that silioon technology is approaching its lim iting feature size, estim ated at around 1985 to be about 1 m [101]. M ore than thirty years later and w ith FET gate lengths getting below 10nm [102], the sam e notion that silicon needs to be replaced at som e point by other technologies oats again. W e do not know whether altematives w ill continue to be steam rollered by silicon technology, which is a leading nanotechnology at the $m$ om ent, but the m ounting resistance to the fam ed M oore's law requires to look hard at other solutions for pow er dissipation, leakage current, crosstalk, speed, and other very serious problem s. T here are very interesting developm ents in studying electronic transport through $m$ olecular m s but the $m$ echanism $s$ of som $e$ observed conductance \sw itching" and/or nonlinear electric behavior rem ain elusive, and this interesting behavior rem ains interm ittent and not very reproducible. M ost of the currently observed sw itching is extrinsic in nature. For instance, we have discussed the e ect of m olecule-electrode contact: the tilting of the angle at which the conjugated molecule attaches to the electrode $m$ ay dram atically change its conductance, and that probably explains extrinsic \telegraph" sw itching observed in Tour wires [23, 34] and molecule recon gurationsm ay lead to sim ilar phenom ena in other system $s$ [67]. D efects in $m$ olecular lm s have also been discussed and $m$ ay result in spurious peaks in $I-V$ curves. W e have outlined som e designs of the $m$ olecules that $m$ ay dem on-
strate rectifying behavior, which we callm olecular \quantum dots". W e have show $n$ that at least in som e specialcases $m$ olecular quantum dotsm ay exhibit fast ( THz ) intrinsic sw itching.

The author is grateful to Jeanie Lau, Jason P itters and R obert W olkow for kind perm ission to use their data and gures. The work has been partly supported by DARPA.

## $R$ eferences

1. JM . Tour, A cc. C hem . Res. 33, 791 (2000).
2. C. Joachim, N anotechnology 13, R 1 (2002).
3. A. A viram and M A. R atner, C hem . Phys. Lett. 29, 277 (1974).
4. A S.M artin, JR.Sam bles, and G J. A shwell, Phys. R ev. Lett. 70, 218 (1993); R . M . M etzger, B. Chen, U. H opfner, M . V. Lakshm ikantham, D.Vuillaum e, T.K awai, X.W u, H. Tachibana, T.V.H ughes, H Sakurai, J. W . Baldw in, C . H osh, M . P. C ava, L. B rehm er, and C. J. A shw ell, J. Am . C hem . Soc. 119, 10455 (1997).
5. K . Stokbro, J. T aylor, and M .B randbyge, J.A m . C hem . Soc. 125, 3674 (2003). 6. J.C.E llenbogen and J. Love, IEEE P roc. 70, 218 (1993).
6. A S.D avydov, $T$ heory of $M$ olecular $E x c i t o n s ~(M ~ O G ~ r a w ~ H i l l, ~ N ~ e w ~ Y ~ o r k, ~ 1962) . ~$ 8. F. G utm ann, N ature 219,1359 (1968).
7. A.S.D avydov, J.T heor. B iol. 66,379 (1977); A S.D avydov and N .I.K islukha, P hys. Status Solidi (b) 75, 735 (1976).
8. A. Scott, P hys. Reports 217 , 1 (1992).
9. JF. Scott, Ferroelectric M em ories (Springer, B erlin, 2000).
10. G. A twood and R.Bez, presentation at ISIF11 (H onolulu, 21-27 A pril, 2006); W .Y.Cho et al., ISSCC D ig. Tech. papens (2004); G.W icker, SP IE 3891, 2 (1999); S R.O vshinsky, Phys. R ev. Lett. 21, 1450 (1968).
11. D. J. Jung, K . K im, and J.F. Scott, J. Phys. C ondens. M at.17, 4843 (2005).
12. Y. H iranaga and Y.Cho, 11th Intl.M tg. Ferroel. (IM F 11, Iguassu Falls, B razil, Sep 5-9, 2005).
13. T.I. K am ins, Interface 14, 46 (2005); Self-assem bled sem iconductor nanow ires, in $T$ he $N$ ano-M icro Interface, edited by $H$. J. Fecht and $M$. W emer ( $W$ ileyVCH, 2004), p. 195.
14. E. R abani, D R. Reichm an, P L. G eissler, and L E. B rus, N ature 426, 271 (2003).
15. M .C. Petty, Langm uir-B lodgett $F$ im s (C am bridge U niversity P ress, C am bridge, 1996).
16. A. U m an, C haracterization of O rganic T hin Fims (Butterw orth $H$ einem ann, B oston, 1995).
17. G. Snider, P.K uekes, and R S.W illiam s, N anotechnology 15, 881 (2004).
18. B . Stadlober, M . Z irkl, M . B eutl, G. Leising, S.B auer-G ogonea, and S . B auer, A ppl. P hys. Lett. 86, 242902 (2005); JM. Shaw and P F. Seidler, IBM J.Res. Dev. 45, 3 (2001).
19. S. D atta et al, P hys. Rev. Lett. 79, 2530 (1997).
20. A M . B ratkovsky and P E. K omilovitch, Phys. R ev. B 67, 115307 (2003).
21. P E.K omilovitch and A M . B ratkovsky, Phys. R ev. B 64, 195413 (2001).
22. N.Ness, S.A. Shevlin, and A.J.F isher, Phys. Rev.B 63, 125422 (2001).
23. W P.Su and J.R.Schrie er, P roc. N atl. A cad. Sci. 77, 5626 (1980); S A. B razovskii, Sov. Phys. - JETP 51, 342 (1980).
24. S. A. B razovskii and N . N . K irova, Zh. Eksp. Teor. Fiz. P is'm a Red. 33, 6 (1981) [JETP Lett. 33, 4 (1981)].
25. A. Feldblum et al, Phys. Rev.B 26, 815 (1982).
26. R R.Chance, JL.B redas, and R . Silbey, Phys. Rev. B 29, 4491 (1984).
27. M .G.Ram sey et al., Phys. Rev. B 42, 5902 (1990).
28. D . Steinm uller, M .G.R am sey, and F P.N etzer, P hys. R ev.B 47, 13323 (1993).
29. L S. Swanson et al, Synth. M etals 55, 241 (1993).
30. M . Jaisw al and R . M enon, P olym er Intl. 55, 1371 (2006).
31. J. C hen, M .A.Reed, A.M . R aw lett, and J.M . Tour, Science 286, 1550 (1999).
32. Z J. D onhauser, B A. M antooth, K F. K elly, L A. Bum m, J D . M onnell, J J. Stapleton, D .W . P rice, Jr., A . M . R aw lett, D . L. A llara, J. M . T our, and P . S . W eiss, Science 292, 2303 (2001); Z.J.D onhauser, B A .M antooth, T P.P earl, K F. K elly, S.U . N anayakkara, and P.S.W eiss, Jpn. J. A ppl. P hys. 41, 4871 (2002).
33. C. Li, D. Zhang, X. Liu, S. H an, T. Tang, C. Zhou, W . Fan, J. K oehne, J. H an, M . M eyyappan, A M . R aw lett, D .W . P riae, and J M . T our, A ppl. P hys. Lett. 82 , 645 (2003); M A. R eed, J. C hen, A M . R aw lett, D.W. P rice, and J. M . Tour, Appl. Phys. Lett. 78, 3735 (2001).
34. C P. C ollier, E.W . W ong, M . B elohradsky, F.M . R aym O, J.F . Stoddart, P . J. K uekes, R.S.W illiam s, and J.R.H eath, Science 285, 391 (1999); C P.C ollier, G .M attersteig; E. W .W ong, Y .Luo, K . B everly, J. Sam paio, F M . R aym O, J F . Stoddart, JR.H eath, Science 289, 1172 (2000).
35. Y. C hen, D A A. O hlberg, X .Li, D R. Stew art, and R S.W illiam S, J.O . Jeppesen, K A. N ielsen, and JF. Stoddart, D L. O lynick, and E. A nderson, Appl. Phys. Lett. 82, 1610 (2003); Y. Chen, G.Y.Jung, D A A Ohberg, X . Li, D R Stew art, J.O Jeppesen, K A N ielsen, J F. Stoddart, and R S.W illiam S, N anotechnology 14462 (2003).
36. D. R . Stew art, D.A.A. Ohlberg, P.A.Beck, Y. C hen, R.S.W illiam S, J. O . Jeppesen, K. A. N ielsen, and J. F. Stoddart, N anoletters 4, 133 (2004).
37. M olecular Sw itches, edited by Ben L. Feringa (W iley $-V C H, 2001$ ).
38. G . Zheng, F . P atolsky, Y iC ui, W .U .W ang, C M . Lieber, N ature B iotechnology 23, 1294 (2005).
39. A . B achtold, P . H adley, T . N akanishi, and C . D ekker, Science 294:1317 (2001); P .G . C ollins, M S.A mold, and P A vouris, Science 292, 706 (2001); T . R ueckes, K . K im , E. Joselevich, G .Y. T seng, C.-L. C heung, and C M . Lieber, Science 289, 94 (2000).
40. M . O uyang and D D.Aw schalom, Science 301, 1074 (2003).
41. C. K rzem inski, C.D elenue, G. A llan, D. Vuillaum e, and R M . M etzger, P hys. Rev.B 64, 085405 (2001).
42. C. Zhou, M R.D eshpande, M A.Reed, L. Jones II, and J M . Tour, A ppl. P hys. Lett. 71, 611 (1997).
43. Y. X ue, S D atta, S.H ong, R . R eifenberger, J.I. H enderson, C P.K ubiak, P hys. Rev.B 59, 7852 ( R ) (1999).
44. J. R eichert, R. Ochs, D. Beckm ann, H. B. W eber, M. M ayor, and H.v. Lohneysen, Phys. R ev. Lett. 88, 176804 (2002).
45. P E. K omilovitch, A M . B ratkovsky, and R S.W illiam s, Phys. Rev. B 66, 165436 (2002).
46. S. Lenfant, C . K rzem inski,C . D elerue, G. A llan, D. Vuillaum e, N anoletters 3, 741 (2003).
47. B . Larade and A M . B ratkovsky, P hys. R ev. B 68, 235305 (2003).
48. S. Chang, Z. Li, C N. Lau, B. Larade, and R S.W illiam s, A ppl. Phys. Lett. 83, 3198 (2003).
49. J. Taylor, H. G uo and J. W ang, Phys. R ev. B 63, R 121104 (2001); ibid. 63, 245407 (2001); A P. Jauho, N S.W ingreen and Y.M eir, Phys. R ev.B 50, 5528 (1994).
50. A S.A lexandrov and A M . B ratkovsky, Phys. R ev. B 67, 235312 (2003).
51. C. B oulas, J.V . D avidovits, F. R ondelez, and D . Vuillaum e, Phys. R ev. Lett. 76, 4797 (1996).
52. E E. P olym eropoulos and J. Sagiv, J. C hem . Phys. 69, 1836 (1978).
53. R H. Tredgold and C S.W inter, J. Phys. D 14, L185 (1981).
54. H. C archano, R . Lacoste, and Y. Segui, A ppl. P hys. Lett. 19, 414 (1971); N R . C ouch, B. M ovaghar, and IR . G irling, Sol. St. C om m un. 59, 7 (1986).
55. I. Shlim ak and V.M artchenkov, Sol. State C om m un. 107, 443 (1998).
56. C N. Lau, D. Stew art, R S. W illiam S, and D. Bockrath, N ano Lett. 4, 569 (2004).
57. J. R odriguez C ontreras, H . K ohlstedt, U . P oppe, R . W aser, C . Buchal, and N . A. P ertsev, A ppl. P hys. Lett. 83, 4595 (2003).
58. R A. W assel, G M . C redo, R R.Fuierer, D L. Feldheim , C B. G orm an, J. A m . C hem. Soc. 126, 295 (2004).
59. J. H e and S M . Lindsay, J.Am. C hem . Soc. 127, 11932 (2005).
60. J. G audioso, L J. Lauhon, and W . H o, Phys. R ev. Lett. 85, 1918 (2000).
61. S.W . H la, G . M eryer, and K .H . R ieder, C hem . P hys. Lett. 370, 431 (2003).
62. G. Yang and G.Liu, J. Phys. C hem . B 107, 8746 (2003).
63. A . Salom on, R. A rad-Y ellin, A . Shanzer, A . K arton, and D J. C ahen, Am . C hem . Soc. 126, 11648 (2004).
64. N P. G uisinger, M E.G reene, R.Basu, A.S.Baluch, M .C. H ersam, N ano Lett. 4,55 (2004).
65. J. L. P itters and R A.W olkow, N ano Lett. 6, 390 (2006).
66. T . R akshit, G .C.Liang, A .W . G hosh, and S.D atta, N ano Lett. 4, 1803 (2004).
67. A.V. Bune, V M . Fridkin, S. D ucharm e, L M . B linov, S P. Palto, A. Sorokin, S.G.Yudin, and A. Z latkin, N ature 391, 874 (1998).
68. S. D ucharm e, V. M . Fridkin, A. V. Bune, S. P. P alto, L. M . B linov, N. N . P etukhova, and S.G.Yudin, Phys. Rev. Lett. 84, 175 (2000).
69. A M . B ratkovsky and A P. Levanyuk, P hys. R ev. Lett. 87, 019701 (2001).
70. A. B une, S. D ucharm e, V . Fridkin, L B linov, S. P alto, N. P etukhova, and S. Yudin, A ppl. P hys. Lett. 673975 (1995).
71. T . Furukaw a, M . D ate, M . O huchi, and A. Chiba, J. A ppl. Phys. 56, 1481 (1984).
72. P E. K omilovitch, A M . B ratkovsky, and R S. W illiam s, Phys. Rev. B 66, 245413 (2002).
73. D .V.A verin and K K . Likharev, in: M esocopic P henom ena in Solids, edited by B L. A ltshuler et al. ( N orth H olland, A m sterdam, 1991).
74. H. Park, J. Park, A K L. Lim, E H. A nderson, A P. A livisatos, and P L. M cEuen, N ature 407, 57 (2000); J. Park, A N . Pasupathy, J.I. G oldsm th, C.Chang, Y. Y aish, J R . P etta, M . R inkoski, J P. Sethna, H D. A bruna, P L. M CE uen, and D .C. R alph, ibid. 417, 722 (2002); W . Liang, M P. Shores, M . B ockrath, JR. Long, and H. P ark, ibid. 417, 725 (2002).
75. N B. Zhitenev, H.M eng, and Z.Bao, Phys. R ev. Lett. 88, 226801 (2002).
76. A S. A lexandrov, A M . Bratkovsky, and R S. W illiam S, Phys. Rev. B 67, 075301 (2003).
77. A S.A lexandrov and A M . B ratkovsky, cond -m at/0606366.
78. M . G alperin, M A. R atner, and A . N itzan, N ano Lett. 5, 125 (2005).
79. A S. A lexandrov and N F. M ott, P olarons and B ipolarons (W orld Scienti C, Singapore, 1996).
80. Y. M eir and N S.W ingreen, P hys. R ev. Lett. 68, 2512 (1992).
81. G D.M ahan, M any-P article Physics, 2nd ed. (P lenum, N ew York, 1993).
82. A. M itra, I. A leiner, and A.M illis, P hys. R ev. Lett. 94,076404 (2006).
83. D . M ozyrsky, M . B . H astings, and I.M artin, Phys. R ev.B 73, 035104 (2006).
84. A.M itra, I. A leiner, and A.M illis, P hys. R ev. B 69, 245302 (2004).
85. H. Park, J. Park, A K L. Lim, E H. A nderson, A P. A livisatos, and P L. M cEuen, Nature 407, 57 (2000); J. Park, A N . P asupathy, J.I. G oldsm th, C. Chang, Y .Y aish, JR.Retta, M . R inkoski, J P . Sethna, H D. A bruna, P L. M CEuen, and D .C.R alph, N ature (London) 417, 722 (2000); W . Liang et al, N ature (London) 417, 725 (2002).
86. H. Sakaguchi, A . H irai, F. Iw ata, A. Sasaki, and T. N agam ura, A ppl. Phys. Lett. 79, 3708 (2001); X D. Cui, X . Zarate, J. Tom fohr, O F. Sankey, A. P rimak, A.L.M oore, T A. M oore, D. G ust, G. H arris, and S.M.Lindsay, N anotechnology 13,5 (2002).
87. W . W ang, T. Lee, and M A. Reed, Phys. Rev. B 68, 035416 (2003).
88. D R. Stew art, D A A.Ohlberg, P A.Beck, C N. Lau, and R S.W illiam S, A ppl. Phys. A 80, 1379 (2005).
89. G L. F isher, A E. H ooper, R L. O pila, D L. A llara, and N . W inograd, J. Phys. C hem. B 104, 3267 (2000); K . Seshadri, A M .W ilson, A. G uiseppiت lie, D L. A llara, Langm uir 15, 742 (1999).
90. A.V.W alker, T B.Tighe, O. C abarcos, M D. R einard, S.U ppili, B C. . H aynie, N. W inograd, and D.L.A llara, J. Am. Chem. Soc. 126, 3954 (2004).
91. M . P ollak and J J. H auser, Phys. Rev. Lett. 31, 1304 (1973); IM . Lifsh itz and V.Ya.K inpichenkov, Zh. Eksp. Teor. Fiz. 77, 989 (1979).
92. L.I. G lazm an and K A.M atveev, Sov. Phys. JE TP 67, 1276 (1988).
93. Y. Xu, D.Ephron, and M R.Beasley, Phys. R ev.B 52, 2843 (1995).
94. C H. Shang, J. N owak, R. Jansen, and J.S.M oodera, Phys. R ev. B 58, 2917 (1998).
95. Y. Selzer, M A.C abassi, T S.M ayer, D L A llara, J. A m . C hem . Soc. 126, 4052 (2004).
96. N B. Zhitenev, A.Enbe, and Z.Bao, Phys. Rev. Lett. 92, 186805 (2004).
97. M . J. Frisch, GAUSSIAN 98, Revision A.9, G aussian, Inc., P ittsburgh, PA, 1998.
98. A.I. Larkin and K A.M atveev, Zh.Eksp. Teor. Fiz. 93, 1030 (1987).
99. N .G . R am bidiand V M .Zam alin, M olecular M icroelectronics: O rigin and O utlook (Znanie, M oscow, 1985).
100. M . Ieong, B . D oris, J. K edzierski, K . R im , M .Y ang, Science 306, 2057 (2004).

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